S-4 SAMPLING HEAD

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INSTRUMENT SERIAL NUMBERS

Each instrument has a serial number on a panel insert, tag, or stamped on the chassis. The first number or letter designates the country of manufacture. The last five digits of the serial number are assigned sequentially and are unique to each instrument. Those manufactured in the United States have six unique digits. The country of manufacture is identified as follows:

B000000	Tektronix, Inc., Beaverton, Oregon, USA
100000	Tektronix Guernsey, Ltd., Channel Islands
200000	Tektronix United Kingdom, Ltd., London
300000	Sony/Tektronix, Japan
700000	Tektronix Holland, NV, Heerenveen, The Netherlands

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THE FOLLOWING SERVICING INSTRUCTIONS ARE FOR USE BY QUALIFIED PERSONNEL ONLY. TO AVOID PERSONAL INJURY, DO NOT PERFORM ANY SERVICING OTHER THAN THAT CONTAINED IN OPERATING INSTRUCTIONS UNLESS YOU ARE QUALIFIED TO DO SO.

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Abbreviations and symbols used in this manual are based on or taken directly from IEEE Standard 260 "Standard Symbols for Units," MILSTD-12B and other standards of the electronics industry. Change information, if any, is located at the rear of the manual.



0896-03

Fig. 1-1. Type S-4 Sampling Head.

TYPE S-4 SPECIFICATION

GENERAL INFORMATION

The type S-4 Sampling head is an input signal processing unit for Tektronix sampling units. Input characteristics of the sampling system are determined by the Type S-4. The Type S-4 has an input impedance of 50 Ω and a rise time of 25 ps or less.

The Type S-4 can be installed directly into a sampling unit or used remotely on optional 3 foot or 6 foot extender cable. A portion of the signal delivered to the sampling head input is coupled to the sampling unit for use as an internal trigger signal. Use of this trigger pickoff signal is dependent upon the type of vertical sampling unit and sampling sweep unit used in the system. See the instruction manual for your vertical sampling unit and sampling sweep unit for further information.

The vertical deflection factor of the sampling system is labeled at the top of the Type S-4 as mVOLTS/DIV. The label refers to the sampling unit Units/Div switch.

NOTE

The electrical characteristics in this section are applicable for an instrument calibrated with ambient temperatures between $+20^{\circ}$ C and $+30^{\circ}$ C, and after a 5 minute warm-up. Unless otherwise stated, electrical characteristics apply over an operating temperature range from 0° C to $+50^{\circ}$ C and to an altitude of 15,000 feet. Supplemental information items are for information only and are not specifications.

Table 1-1 SPECIFICATIONS

Characteristic	Performance Requirements		Supplemental Information	
Step Response		3		
Risetime	25 ps or less			
Observed with S-50 or S-52				35 ps or less
Aberrations		Time From Step With 284		
	With S-50 or S-52			
	0 - 400 ps	400 ps - 25 ns	After 25 ns	<i>"</i>
	-10%, +10% or less; total less than 20% p-p	0%, +10% or less; total less than 10% p-p	+2%, -2% or less; total less than 4% p-p	
Displayed Noise	5 mV or less, measured tangentially			

Table 1-1 (cont)

Characteristic	Performance Requirements	Supplemental Information
Dot Transient Response	Within 5% for input signals up to 500 mV P-P	Plug-in unit may require adjustment of DOT RESPONSE control when switching Units Div. Avalanche voltage may have to be readjusted with extreme ambient temperature.
Signal Voltage		
Maximum Operating	1 V P-P	Maximum DC limits which may be displayed depend on DC OFFSET range and Deflection Factor
Safe Overload	Do not exceed $+$ or -5 V limits	
Input R	50 Ω within 5%	
Baseline Shift With Repetition Rate Change	10 mV or less from 30 Hz to 50 kHz	
Temperature		
Nonoperating	-40°C to +65°C	
Operating	0°C to +50°C	
Altitude		
Nonoperating	To 50,000 feet	
Operating	To 15,000 feet	
Vibration		
Operating	15 minutes along each axis at 0.015". Vary the frequency from 10 to 50 to 10 c/s in 1-minute cycles. Three minutes at any resonant point or at 50 c/s	
Shock		
Nonoperating	1000 g's, 1/2 sine, 1/2 ms duration, 2 shocks per axis. Total of 6 shocks	
Transportation	Qualifies under National Safe Transit Committee Test Procedure Category IV (48 inch drop)	

OPERATING INSTRUCTIONS

General Information

This section provides the basic information required for operation of the Type S-4 Sampling Head.

The Type S-4 can be used on an extender cable without compromising the response of the measurement system. Signals are applied to the 50 Ω input of the samping head through a 3 mm, 50 Ω coaxial connector.

Unity loop gain can be obtained with input signals of up to 0.5 volt (peak-to-peak). Unity loop gain ensures the most accurate displays during fast changes in input signal amplitude. See the Basic Sampling Principals Section of your sampling unit manual for further information.

The Type S-4 may be used with input signals up to 1 volt (peak-to-peak). Specifications for the Type S-4 Sampling Head are given in Section 1 of this manual.

NOTE

Attenuators, with threaded 3 mm connectors, are available as optional accessories. These attenuators are useful in reducing the amplitude of large signals. Other optional accessories with 3 mm connectors include coaxial cables, a 50 Ω termination, and adapters for interconnecting various types of connectors.

Installation instructions are located in the vertical sampling unit instruction manual.

Effect of Excessive Input Voltage

A maximum operating signal voltage of 1 volt (peak-to-peak) is specified for the Type S-4 in Section 1 of this manual. Signals having an amplitude of more than 1 volt (P-P) at the Type S-4 input may be distorted by the samping head. Large signals must be reduced in amplitude to not more than 1 volt (P-P) at the Type S-4 input.

WARNING

Signals in excess of plus 5 volts or minus 5 volts may destroy the sampling diode bridge.

A 15 volt (P-P) signal can be reduced to a suitable amplitude at the Type S-4 input by inserting a series combination of 10X and 2X attenuators in the coaxial line delivering the signal. A series combination of 10X and 5X attenuators would also be satisfactory.

See the discussion on Sine Wave Signal measurements later in this section for information on signal amplitude affect upon display amplitude accuracy.

Risetime Measurements

Accurately determining risetime from an observed display requires that the position of the 10% and 90% points be accurately known and that the horizontal distance between these points be accurately measured. The timing accuracy of the sampling sweep unit must also be known. Switching the sampling sweep unit from one oscilloscope to another requires readjustment of the horizontal gain control on the sampling sweep front panel. See your sampling sweep unit instruction manual for timing accuracy specifications and complete instructions for checking timing.

Displayed Risetime and Actual Risetime

Differences in displayed and actual signal risetime will result unless the risetime of the sampling system is about four times faster than the risetime of the signal to be measured. As used in this discussion, the sampling system is considered to be made up of the sampling head and any coaxial line, connectors or accessories between the signal source and the sampling head. Displayed risetime is dependent upon the risetime of the sampling head, the risetime of the pulse generator, and the risetime of the cable and connecting components between the generator and sampling head. With signals as fast as about 100 ps arriving at the Type S-4 input, the displayed risetime will be very close to the actual signal risetime.

Since the risetime of the Type S-52 Pulse Generator output signal is much faster than 100 ps, the displayed risetime (with this pulse applied to the Type S-4 input) will not be the actual signal risetime.

The risetime of signals that are faster than 100 ps can still be determined using the Tektronix Type S-4 Sampling head. However, the signal risetime is calculated using formula (2-2). Signal risetime calculated using formula (2-2) will provide a close approximation of the actual signal risetime.

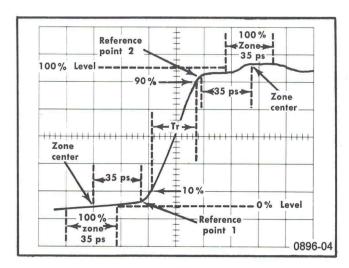


Fig. 2-1. Special S-4/S-52 system risetime measurement technique.

The relationship between displayed risetime, signal risetime, signal path risetime, and sampling head risetime is shown by formula (2-1). T_r of signal path, and T_r of Type S-4 in formula (2-1). T_r of signal path includes the combined risetime of all coaxial cables, connectors, or accessories between the signal source and the Type S-4 input. If the signal path consists of a coaxial cable having a risetime of 8 ps and connectors and accessories having a risetime of 6 ps, the combined signal path risetime is

$$(8)^2 + (6)^2 \approx 10 \text{ ps}$$

$$T_r$$
 (displayed) \approx

$$\sqrt{(T_r \text{ signal})^2 + (T_r \text{ of sig. path})^2 + (T_r \text{ of Type S-4})^2}$$
 (2-1)

For example, assuming an input signal having a risetime of 25 ps; connecting cable, accessories, and connectors having a risetime of 10 ps; and a sampling head with a risetime of 25 ps gives:

$$T_r$$
 (displayed) $\approx \sqrt{(25)^2 + (10)^2 + (25)^2}$
 T_r (displayed) $\approx \sqrt{625 + 100 + 625}$

 T_r (displayed) ≈ 37 ps

Transposing formula 2-1 to permit calculation of signal risetime when the displayed risetime, signal path risetime, and sampling head risetime is known gives:

$$T_r$$
 (signal) \approx
$$\sqrt{(T_r \text{ displayed})^2 + (T_r \text{ of Type S-4})^2 - (T_r \text{ of sig. path})^2} \end{(2-2)}$$

Additional information concerning the effect of connecting cables on the displayed signal risetime may be found under Cable and Accessory Considerations later in this section.

Sine Wave Signal measurements

The parameters of the Type S-4 are specified using pulse or time domain parameters and nomenclature. The frequency response characteristics of the unit, while not specified, are such that it may be used for relative sine wave measurements through its calculated upper 3 dB rolloff point of 14 GHz.

Because of the traveling wave gate used in the Type S-4, it is capable of handling very large signals as compared to other microwave samplers. Even so, the peak to peak signal amplitude should be held to as low a level as possible consistent with good signal to noise ratio when making checks in the 5 to 15 GHz region to avoid compression effects.

Cable and Accessory Considerations

When connecting a signal to the Type S-4 it is important that the signal coupling cable, connectors, attenuators and any other devices between the signal source and sampling head have the correct characteristic impedance, be capable of handling the signal frequency without causing excessive loss or distortion, and be of high quality. Care must be taken to firmly tighten all connectors, or unwanted reflections may result.

Accurate displays of signals containing very fast transitions or very high frequencies are possible only if the cables carrying the signal to the sampling head do not distort the signal. The Type S-4 input resistance is $50~\Omega$ and requires the use of high quality, low loss, $50~\Omega$ coaxial cables and attenuators between the signal source and the sampling head input connector. Using an adaptaer to change from 3 mm to a larger diameter coaxial cable will result in a loss of system bandwidth.

The Type S-4 sampling head is useful from DC up to at least 14 GHz. Standard and optional 3 mm accessories available from Tektronix are intended for use at frequencies to 18 GHz and are generally useful at frequencies to 25 GHz. Since any accessories in the path between the signal source and the Type S-4 input will increase the displayed signal risetime, use only high quality accessories of adequate high frequency capability. Accessories (3 mm) supplied with the Type S-4, or available as optional equipment, include flexible and rigid coaxial cable, attenuators, adapters to change from 3 mm to larger size coaxial cable, and a power divider.

The physical and electrical characteristics of the cable determine the characteristic impedance, velocity of propagation and nature of signal losses.

It is important to use cables or airlines, in the signalhandling side of the system, that are as short as possible.

Use of the optional 3 foot or 6 foot head extender cable permits locating the Type S-4 near the signal source and thereby keeps the input coaxial cable short and signal losses to a minimum. Signal losses along a coaxial line, due to skin effect or dielectric loss, result in a loss of high-frequency signal amplitude as the signal travels along the line. Dielectric loss along the coaxial line also results in an increase in the displayed risetime of fast step pulses. Dielectric and skin effect losses increase with signal frequency and the length of the coaxial cable. Fig. 2-2A shows the displayed waveform when the 25 ps output pulse of the Type S-52 is fed to the Type S-4 input through a rigid 3 mm coaxial line. In Fig. 2-2B the 25 ps pulse is fed to the S-4 input through a 5 ns length of flexible 3 mm coaxial cable. Fig. 2-2C shows the risetime of the displayed signal when the same 25 ps pulse is sent through a 5 ns length of good quality coaxial cable similar to Type RG-58/U. The importance of using a short length of the proper type coaxial between the signal source and the Type S-4 input is apparent from comparison of the waveforms of Fig. 2-2.

Another factor that can result in loss of signal in a coaxial cable is use of coaxial cable having a diameter that is large compared to the wavelength of the highest frequency components of the signal. The Type S-4 input connector is intended for use with Teflon dielectric coaxial cable having an outer conductor with an outside diameter of 0.141 inches.

Resistive losses in large diameter coaxial cable is less than in smaller diameter cable for frequencies below the critical value.

CAUTION

The two coaxial lines listed under part numbers 015-1015-00 and 015-1005-00 must be treated with care to obtain maximum life and least signal distortion. The rigid line may not have its shape changed and still have the propagation delay and Z_o guaranteed. In cases where the line is not used at its maximum performance limits, small amounts of bending can be made providing mating connectors are on each end before bending. If bent to a curve radius of 1 1/2 inches, the line may be made totally inoperative. The flexible cable must not be given a bend radius less than 10 times its OD, or approximately 2 1/4 inches. Flexible cables may suffer outer conductor breakage by tighter bending. Few flexures assure longer life.

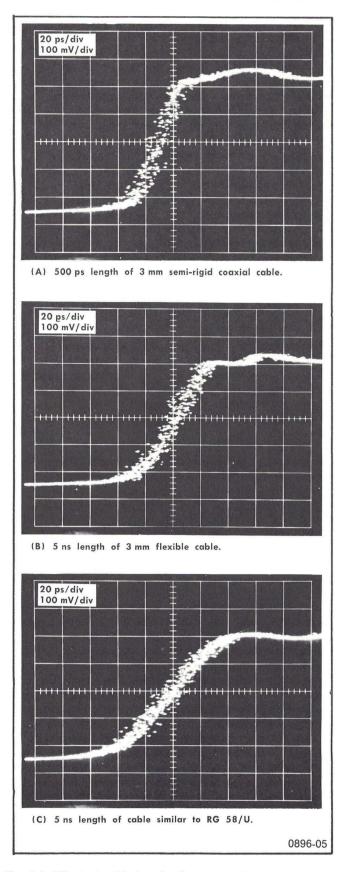
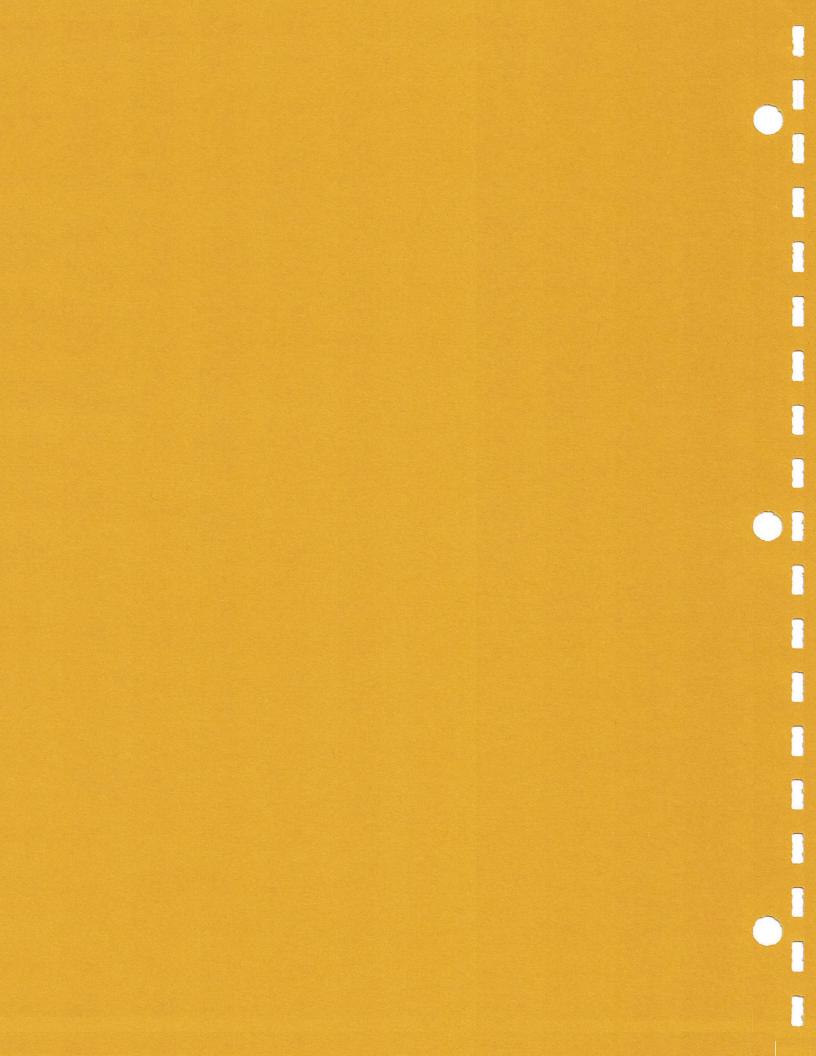


Fig. 2-2. Effect of cable length, diameter, and quality on displayed risetime.

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CIRCUIT DESCRIPTION

General

This section of the manual contains a block diagram description of the Type S-4 Sampling Head followed by a detailed circuit description. Both the block and schematic diagrams are located at the rear of this manual.

The Type S-4 is the signal input section of a sampling system, and determines the vertical channel input characteristics.

BLOCK DIAGRAM

Both the Block Diagram and the circuit schematic show the Type S-4 circuits outlined by dashes, indicating the individual circuit boards within the unit. One circuit board is devoted to the generation of the sampling gate strobe pulses, one to the sampling gate, one to the blow-by and trigger pickoff amplifier and one to the preamplifier.

Stobe Generator

The Strobe Generator develops heavy-current (several mA), short-duration, push-pull pulses that drive the Sampling Gate into balanced conduction. Output occurs at the time of each sample when a command pulse arrives from the Stobe Driver circuit of the associated sampling unit. The pulse lasts for a period of about 125 ps, turning on the Sampling Gate diodes. At the end of the pulse, the diodes turn off very quickly, retaining a portion of the input signal. Strobe pulse duration and fall time are fixed by the Snap-Off diode D61, and the two clipping lines. The Strobe Generator parts layout and circuit board construction are carefully controlled during manufacture to ensure proper strobe pulses being sent to the Sampling Gate.

Sampling Gate

The Sampling Gate (called the Sampling Bridge in other Tektronix sampling circuitry) connects the input signal to the Preamplifier only during the short time when each sample is taken. The six diodes, D2A through D2F, form what is technically termed a traveling wave gate. It is the way the end of the Strobe Drive pulse travels through the gate that determines the step response of the sampler. In other Tektronix sampling bridges, the step response risetime is controlled by the strobe pulse duration. In the Type S-4, the step response risetime is controlled instead by the length of time it takes the end of the strobe pulse to travel through part of the Sampling Gate.

At the end of each Strobe pulse, part of the input signal is stored temporarily between Sampling Gate diodes and is then fed to the Preamplifier input at a rate much slower than the step response risetime. It is only the special traveling wave gate that has its electrical environment controlled for minimum reflections of fast pulse signals. All circuit parts that pass the sampled error signal (see the sampling unit manual section on Basic Sampling Principles for definition of error signal) to the Preamplifier handle only moderate rate-of rise signals. A special 10X (20 dB) 50 Ω attenuator helps serve as a high-quality, high-frequency termination to the input connector and the 50 Ω environment of the traveling wave gate.

Part of the input signal is continuously passed to the Trigger Amplifier Board and the Blow-by compensating and Trigger Pickoff circuit. The signal passes through the 10X attenuator directly to the Trigger Amplifier Board and is terminated in 50 Ω there.

Gate Bias

Reverse bias is applied to the Sampling Gate diodes by the Gate Bias circuit. The average voltage of the gate bias is controlled by the Gate Balance circuit and the associated sampling unit DC Offset and Feedback signals. The Sampling Gate output is DC coupled to the Preamplifier input through a portion of the Gate Bias circuit.

Blow-by and Trigger Pickoff

The primary function of the Blow-by and Trigger Pickoff circuit is to cancel capacitively-coupled unwanted signals that normally bypass the Sampling Gate. These unwanted signals are called "blow-by" signals.

The Type S-4 special traveling wave Sampling Gate contains two blow-by reducing diodes that minimize the unwanted capacitively-coupled signals. The special Sampling Gate construction and the blow-by circuit essentially cancel all of the unwanted signals that would otherwise distort the oscilloscope sampling display.

The Blow-by and Trigger Pickoff circuit receives an attenuated portion of the input signal and terminates the 10X attenuator that is located between the Sampling Gate and the Trigger Amplifier Board. The circuit amplifies and inverts the signal and applies it, as a blow-by correction signal,

Circuit Description—S-4 Sampling Head

through a small capacitor to the output side of the Sampling Gate blow-by limiting diodes. magnitude of the blow-by correction signal is adjusted during calibration by the Transient Response control.

The trigger pickoff function of the Blow-by and Trigger circuit provides an in-phase signal source for internally triggering the sampling sweep unit. Not all channels of all sampling units (in which the S-4 operates) couple the trigger pickoff signal to the sampling sweep unit. If the signal is not used, the sampling unit terminates the output in 50 Ω , allowing the circuit to remain functional for blow-by correction.

Preamplifier

The Preamplifier circuit both amplifies and time-stretches the signal it receives from the Sampling Gate. The signal received is a portion of the difference between the Feedback combined with the DC Offset voltage and the input signal. This "error signal" is amplified and AC coupled to the Post Amplifier in the sampling unit. The Preamplifier gain is adjustable to aid in setting the overall sampling head and sampling unit "loop" gain to unity for proper dot response.

CIRCUIT DESCRIPTION

Refer to the main schematic diagram during the following descriptions. The Type S-4 Sampling Head uses the power supplies of the indicator oscilloscope and associated sampling unit. Interconnections to the sampling unit circuits are by two rear connectors. The following description includes references to circuits in the sampling vertical unit and sampling sweep unit, all units forming one sampling system. Reference to diagrams and circuit descriptions in the instruction manuals for the other sampling units will help in gaining a full understanding of the circuit relationships.

Strobe Generator

The Strobe Generator circuits are all located on the right side Strobe circuit board. The generator contains two basic circuits, an Avalanche circuit that delivers fast push-pull pulses and the Snap-off diode and clipping lines circuit. Both circuits work together to produce the push-pull strobe pulses that drive the special traveling-wave Sampling Gate through two equal transmission lines. Both sets of circuitry are physically arranged over separate ground planes that are identified on the main schematic diagram. The two ground planes are connected together by R52 and R54, to damp out ringing between the two circuit areas at sample time.

The Avalanche Circuit converts the Strobe Drive pulses from the sampling unit to very fast push-pull pulses that drive the Snap-off diode to non-conduction.

The Strobe Drive pulse is transformer-coupled by T75 to the base and emitter of Avalanche transistor Q69. Two outputs are ac-coupled from Q69, one from the collector and the other from the emitter. The Avalanche Volts control adjusts the collector voltage of avalanche transistor Q69. The typical quiescent voltage at Q69 collector is about +15 volts. This voltage sets the amplitude of the signals that drive the Snap-off diode circuit and assures the normal avalanche action of Q69 when driven by the Strobe Drive signal. Before Avalanche conduction, there is a potential of about 60 volts between Q69 collector and emitter.

The negative Strobe Drive pulse is transformed into a hard forward bias signal to Q69. Normal avalanche action follows with the collector going negative and the emitter going positive. This fast-rise, push pull signal is capacitively coupled to the Snap-off circuit.

The Snap-off Circuit operates as a current switching circuit to apply some of the push-pull Avalanche current signal at snap-off time to the Sampling Gate. The circuit consists of a Snap-off Current control R57, Q55, Snap-off diode D61, two clipping lines and associated components. Between drive pulses from the Avalanche circuit, the Snap-off diode D61 is forward-biased by the current in Q55. The current value is set by the Snap-off Current control R57. The current in D61 is typically 20 mA. This forward current assures that D61 has many carriers within its junction region.

The push-pull signals from the Avalanche circuit cause D61 junction carriers to reverse direction as a heavy reverse current. This heavy reverse current stops suddenly as all the carriers clean out of the junction. As the reverse current "snaps" to a stop, the push-pull avalanche signals are suddenly coupled into the clipping lines by C52 and C54 and toward the Sampling Gate by R51-C51 and R53-C53. The fast-rise step which appears at each clipping line input is propagated down the line. About 50 ps later the steps reach the short circuited ends of each clipping line. The step is then reflected, equal in amplitude and opposite in polarity, back to the input end of each clipping line. This cancels the signals moving toward the Sampling Gate. This action results in a positive Strobe pulse being delivered to P53, and a negative Strobe pulse being delivered to P51.

The clipping lines have a surge impedance of approximately 10 Ω with a very good short circuit at the shorted ends. The high quality of the short, and the line low impedance causes the reflected signal to stop the Strobe pulses very rapidly. Such rapid ending of the Strobe pulse and the characteristics of the traveling wave Sampling Gate causes each sampling diode to turn off in approximately 10 ps.

Ringing of the Snap-off diode and the clipping lines is mainly prevented by R50 which is directly across the lines

ends. Ringing is also limited to some degree by the two equal resistors R60 and R62 that are in DC series connection with the Snap-off diode D61. The primary function of R60-R62, however, is to provide a DC path for D61 forward conduction while at the same time allowing the Avalanche signals to pass on into the clipping lines and Sampling Gate. As the Avalanche pulses end and as both the Avalanche and Snap-off circuits recover for another sample, R60-R62 re-establish the correct quiescent charges on C63 and C64. C59 assures a very low impedance AC path for the ground side of R60 so that R60 and R62 will both have the same affect upon the circuit.

Another technique for minimizing Strobe ringing is that of R51 and R53 being in series with the output lines to the Sampling Gate. The output connectors that connect the Strobe board to the Sampler board have a 50 Ω characteristic impedance. R51 and R53 raise the Clipping lines 10 Ω impedance drive to 50 Ω to properly match the connections. Thus, at the end of the Strobe pulse, reflections back from the Sampling Gate are reverse terminated. These resistors and the resistors discussed in the preceeding paragraph all assure that there is no possibility of double strobing of the Sampling Gate due to ringing of the Strobe Generator circuits.

Two separate ground planes are identified on the main schematic diagram between the Avalanche and Snap-off circuits. Two resistors connect the two ground plane ends together to damp any natural ringing when the case is off. Ringing can occur without R52 and R54 because the two ground planes are connected together at the instrument front and rear through the Sampler board. Component layout is organized so the strobe signal ground currents balance to zero at the center of the Sampling Gate, and thus do not contribute unwanted currents to the input signal. Q69 circuit is capacitively isolated from both ground planes as much as possible, with its primary signal output path being through C63-C64 and C52-C54. There is a small third terminal capacitance to ground between the two windings of T75, but it is not large enough to disturb the balanced drive from Q69 to D61.

Sampling Gate and Gate Bias Circuits

The Sampling Gate consists of six series diodes, D2 A through F, and four resistors all mounted on a ceramic substrate inside the input circuit holder. See Fig. 3-1 during the following discussion.

The signal that arrives at J1 travels right on through the Sampling Gate area to a 3 mm 50 Ω 10X (20 db) attenuator. Output of the attenuator feeds the Trigger and Blow-by Compensation circuit where it is terminated in 50 Ω . When not being strobed, D2C and D2D present a very small value of capacitance to the input signal. When the diodes conduct

due to Strobe current, the input line is coupled to the traveling wave gate.

Gate Biasing

Quiescent condition of the Sampling Gate diodes is controlled by the Gate Bias circuit. D2A, D2B, D2E and D2F are each reverse biased about 0.5 volts by D20, D23, D25 and D28. D2C and D2D are reverse biased about 1.2 volts each, a total of about 2.45 V is developed across the parallel combination of R24-C25 of the Gate Bias circuit. The Gate Bias circuit receives its current from the two 50 V supplies and R30-R31-R32-R33 and R34 of the Gate Balance control circuit. The diodes of the Gate Bias circuit are used as 0.5-volt Zener diodes. R2A-R2F with C24 and R2B-R2E with C25 isolate the traveling wave gate segments from the Preamp and Bias circuits R21-R26 conduct DC bias potentials to the gate but allow a sampled error signal to drive C24 and the Preamplifier input.

Except for the very short strobed conduction time (about 125 ps), the Sampling Gate diodes do not conduct. A portion of the input signal is coupled through stray capacitances to the Preamplifier input, and disturbs the normal sampling display. This effect is known as "blow-by".

Blow-by Correction

The basic risetime of the traveling wave Sampling Gate is 25 ps. In this extremely short interval of time, only a very small amount of charge can be collected in one sample. What small charge is collected, is called the error signal and is amplified by the Preamplifier and the sampling unit circuits. The Preamplifier has a shaped frequency response best suited to amplifying each sample's small charge and delivering a proper error signal to the sampling unit.

It is impossible to build a sampling gate without a path for blow-by displacement currents. These currents cause the Preamplifier to respond to a part of some input signals and distort the display. The Type S-4 Preamplifier responds to signals in the 0.5 to 3 MHz bandpass region. Signals much higher or lower in frequency are not amplified. Those blow-by signals in the Preamplifier bandpass region that do get through the Sampling Gate are virtually eliminated by the Blow-By correction amplifier Q10.

Blow-by rejection in the Sampling Gate is assured by the double differentiation networks that have very fast RC times. They are located between the signal input and the Preamplifier. The first differentiation network is formed by reverse biased diodes D2C and D2D and their respective resistors to ground (see Fig. 3-1), R2B and R2E. The second network is formed by diodes and resistors D2B, D2E and R21, R26, respectively. All the Sampling Gate diodes

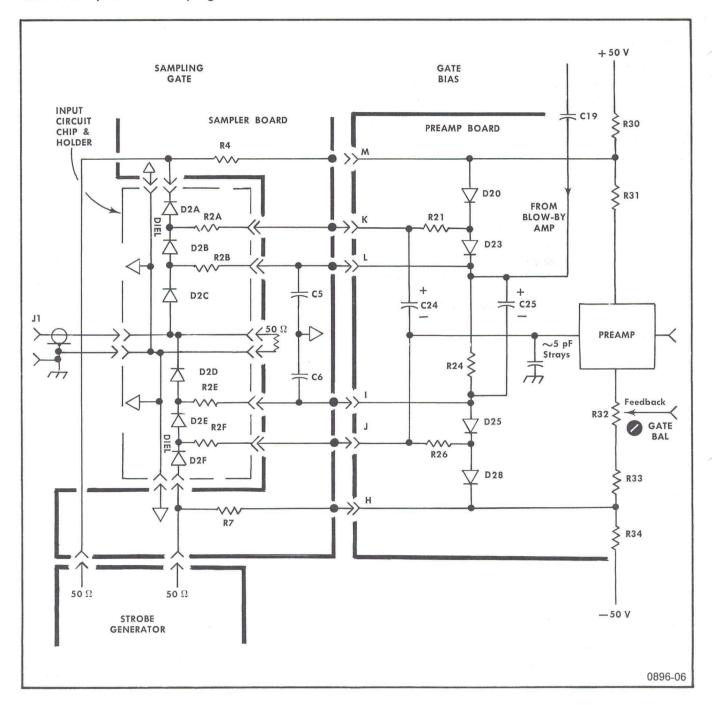


Fig. 3-1. Traveling wave Sampling Gate and Gate Bias circuit components, with input signal blow-by differentiating paths shown by dotted lines.

are normally non-conducting and are therefore very small capacitors. the differentiating networks eliminate all but about 5% of the possible blow-by effects. The Blow-By correction amplifier feeds an inverted replica of the input signal into the Sampling Gate output, and a small quantity of charge passes through C19 to cancel most of the remaining blow-by signal.

Traveling Wave Sampling Gate

Push-pull strobe pulses from the Strobe Generator cause the six Sampling Gate diodes to conduct for about 125 ps. While the diodes are conducting, the signal at the input connector propagates down the diode transmission paths as well as toward the 10X attenuator, R3. As the fast falling strobe pulse end begins to propagate into the diode transmission paths, the diodes are quickly switched off (into reverse bias), one set after another. First, diodes D2A and D2F turn off, then D2B and D2E, and finally D2C and D2D. Turn off time of the diode sets is controlled by the mechanical spacing and thereby the propagation time between sets. The Sampling Gate risetime is determined by these propagation times, and is thus not heavily influenced by the strobe pulse amplitude or duration. The sampling process is thus one of trapping signal charge between sets of diodes, in particular, between set D2A-D2F and the set D2B and D2E. The risetime is very close to the double transit time between sets.

Once the signal charge trapping process has taken place at the strobe pulse end, the Preamplifier begins to receive the trapped charge by conduction through resistors R2A and R2F (See Fig. 3-2). The Preamplifier input capacitance is much larger than the capacitance of the transmission line segments between the diode sets, causing practically all of the trapped charge to finally transfer to the Preamplifier input. The transfer time constant is approximately 10 nanoseconds.

Because of the carefully adjusted balance of the plus and minus strobe signals (set by the physical position of R51 and R53 in the Strobe Generator), the Preamplifier receives only the trapped signal charge and nothing from the Strobe Generator.

Preamplifier

The Preamplifier circuit amplifies and time-stretches the error signal pulse from the Sampling Gate, and AC couples it to the Post Amplifier in the associated plug-in unit.

Input transistor Q36 operates as a very high input impedance, high-gain inverting amplifier. Temperature compensation for Q36 is accomplished by thermistor R38. A total of 4.4 mA channel current passes from the +50 volt supply through R36, Q36, R38 and R40 to the -50 volt supply. C39 assures that Q36 AC gain is high, while its DC gain is less than 1.

Q43 and Q46 are connected as an operational amplifier with a very low output impedance at Q46 emitter. The output is coupled by C50 to the 90 Ω input resistance of the Post Amplifier in the sampling unit. R37 and R39 provide temperature compensation to stabilize loop gain. D41 protects Q43 base from high negative voltage if Q46 is removed from its socket.

Current in R42 with DC negative feedback by R48 sets the output DC voltage level of the amplifier at about 7.3 volts. Negative AC feedback from the emitter of Q46

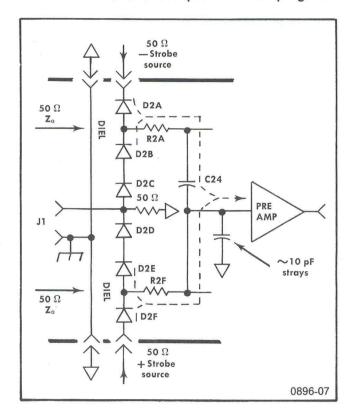


Fig. 3-2. Error-signal source and path to Preamp shown by dotted lines.

through C49 and Gain control R49 to Q43 base controls the AC gain of the Preamplifier. Gain control R49 allows the AC feedback to be adjusted, thereby adjusting the gain. The AC gain is adjusted during calibration so that the sampling head has the correct amplitude output signal to the sampling unit Post Amplifier.

The Type S-4 sampling efficiency is less than 2%. With a low sampling efficiency, the Preamplifier positive and negative signal output impedance must both be low. Q46 assures a low output impedance for positive-going output pulses, and D43 assures a low output impedance for negative-going output pulses. D43 conducts only for large negative output signals that fall at a rate faster than Q46 emitter can follow. Q46 emitter remains a low output impedance for small negative output signals.

Components not already mentioned above include: C47 and R46 that both prevent parasitic oscillations of Q46, and C45-C46 that decouple the +15-volt supply for both low and high frequency current pulses of Q46.

Blow-by and Trigger Pickoff

The Blow-by and Trigger Pickoff circuits consist of Q10, Q14 and associated components connected as a common-

Circuit Description—S-4 Sampling Head

emitter paraphase amplifier. The primary purpose of the circuit is to cancel unwanted high frequency capacitively-coupled signals that bypass the Sampling Gate. The secondary purpose is to provide a trigger pickoff signal to the sampling unit for internal triggering of the sampling sweep unit.

Input signal to the Blow-by and Trigger Pickoff circuit is a portion of the Type S-4 input signal. The signal is fed to the base of Q10 through R3. R11 terminates the $50~\Omega$ impedance of the input and assures no reflections back onto the input circuit. The output from Q10 collector feeds an AC coupled signal to the output side of the Sampling Gate, cancelling the blow-by signal. The output from Q14 collector feeds a DC coupled trigger pickoff signal to the sampling unit for use by the sampling sweep unit.

Feedback Limiting

The Preamplifier input is the input terminal of an integrating pulse amplifier that includes the sampling unit Post Am-

plifier, AC Amplifier, Memory Gate and Memory Amplifier. Feedback from the Memory Amplifier output is DC coupled to the Type S-4 Preamplifier input through the sampling unit Feedback Attenuator and the Type S-4 Gate Bal control.

As a sample is taken, the error signal is amplified and converted to a DC signal for both the CRT and the feedback that arrives through pins 2 and B of the sampler board. The maximum feedback is limited to approximately $\pm\,1.2$ volts by two resistive dividers and D80 and D83. The limiting is to prevent excessive feedback voltge from reaching the Sampling Gate when the sampling unit Units/Div switch is changed between positions. In certain conditions of operation, the excessive feedback can cause the Sampling Gate to go into a mode of conduction that holds the CRT beam off screen. By limiting the feedback amplitude, overdriven displays will leave the CRT screen but will return just as soon as the overdrive is removed. Without the limiting, an overdrive signal could cause the display to disappear.

PERFORMANCE CHECK AND CALIBRATION

This performance check and calibration procedure for the Type S-4 Sampling Head requires the use of the test equipment listed below. The test equipment specifications given are the minimum acceptable for the particular use of each

item. If other test equipment is substituted, it must meet or exceed the stated requirements. All test equipment must be correctly calibrated.

Table 4-1
TEST EQUIPMENT REQUIRED

Description	Requirements	Example
Oscilloscope Mainframe	for sampling Plug-ins	7000 Series Mainframe
Sampling plug-in Vertical	for S-4 sampling Head	7S11
Sampling Horizontal Plug-in	for use with sampling Vertical	7T11
Test Oscilloscope	DC to 30 MHz, 0.5 V/div vertical sensitivity	2213A
10X probe	for use with test oscilloscope	P6120
Signal/Pulse Generator	Pulse rise time 70 ps or or less, amplitude approximately 20 mV into 50 Ω . Trigger 180 mV positive going at least 75 ns in advance of pulse with risetime of \leq 400 ps. Square wave outputs of 1 μ s and 1 ns with 100 mV and 1.0 V amplitude into 50 Ω .	Tektronix Type 284
Pulse Generator	rise time 25 ps or less, amplitude \geqslant 200 mV into 50 Ω with 180 mV positive going trigger at least 75 ns in advance of the fast pulse.	Tektronix Type S52
Rigid Coax line, 3 mm connectors	Test Procedures	Tektronix Part No. 015-1015-00
GR874 to 3 mm adapter plug		Tektronix Part No. 015-1007-00
GR874 to 3 mm adapter jack		Tektronix Part No. 015-1008-00
$50~\Omega$ 2X coaxial attenuator, GR874 connectors		Tektronix Part No. 017-0080-00
Special variable attenuator with GR connectors	Response not guaranteed	Tektronix Part No. 067-0511-00
bnc 50 Ω cable approximately 40 inches long.	(2 required)	Tektronix Part No. 012-0057-01
bnc to bsm cable approximately 18 inches long		Tektronix Part No. 012-0127-00
Special 3 foot extender cable for sampling head		Tektronix Part No. 012-0124-00

Table 4-1 (cont)

Description	Requirements	Example
Clip lead to bnc adapter		Tektronix Part No. 013-0076-00
DC Bridge	For measuring 50 Ω ± 5 Volts maximum across 50 Ω resistor accurate within $\pm 0.5\%$	
RMS line voltage meter	$\pm 3\%$ at input line voltage range	9
Test sampling oscilloscope	For checking strobe kickout.	7000 series with 7T11, 7S11, and a type S-2 sampling head.

PRELIMINARY PROCEDURE

1. Check the 50 Ω DC Input Resistance. With the sampling head separated from the sampling unit, use a DC Resistance Bridge and measure the DC input resistance. Connect one lead to the input connector outer conductor, and the other lead to the center conductor. Be sure the bridge does not apply more than ± 5 volts to the input terminals.

The Type S-4 input resistance must be 50 $\Omega,~\pm 5\%,$ for a resistance reading of 47.5 Ω to 52.5 $\Omega.$

2. Setting up the equipment.

- a. Assembly the indicator oscilloscope system. Place the type 7S11 into the right vertical compartment of the indicator oscilloscope, and the Type 7T11 into the horizontal compartment. Install an operating sampling head into the Type 7S11 compartment.
- b. Connect the RMS line-voltage meter to the power mains. Determine that the oscilloscope (and other equipment) input voltage selector is set for the correct value of line voltage. Connect all the equipment to the proper power outlet and turn on the power.
- c. Obtain a free-running trace on the indicator oscilloscope and let the equipment warm up for five minutes. After the warm-up period, adjust the Trace Alignment control so the free-run trace is parallel to the graticule lines.
- d. Connect the Type 284 Square Wave Output connector to the sampling head input. Use a 5 ns signal delay 50 Ω coaxial cable with GR 874 connectors. Connect the Type 284 Trigger Output connector to the sampling sweep unit External Trigger input (50 Ω) connector, using a BNC 50 Ω coaxial cable.

Set the Type 284 Period at 100 ns Square Wave and the Amplitude at 1 volt. Using the Type 284 as both a time and amplitude reference adjust both the vertical and the horizontal unit screwdriver adjustable Gain controls for proper deflection factor of each unit. Remove sampling head from the 7S11.

e. Install the Type S-4 onto the special three foot extender cable. Connect the other end of the cable into the 7S11 sampling head compartment. Allow a five minute warm up of the system.

NOTE

The case should be in place unless access to internal controls is necessary.

f. Set the controls as listed following Fig. 4-1.

Sampling Unit (Both channels)

Dot Response	Midrange
Unit/Div	100
Variable	Cal
Up	Pushed in
Position	Midrange
DC Offset	0 volts at Offset Out

Sampling Sweep Unit

Rep
Pushed in
50 ns
0.5 μs
Cal
Fully clockwise
Stable Display
+
Ext
Mid-range

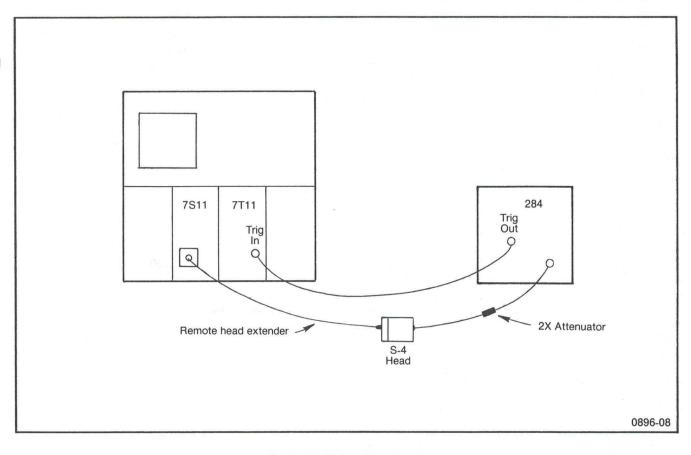


Fig. 4-1. Initial equipment setup.

Type 284

Mode	Square Wave
Period	100 ns
Square Wave Amplitude	1.0 V
Lead Time	75 ns

Test Oscilloscope

Triggering	+ Int, AC
Time/Div	$0.2~\mu s$
Vertical	
With 10× Probe	1.0 V/Div, AC

PERFORMANCE CHECK AND CALIBRATION PROCEDURE

1. Check Ability to Produce a CRT Display

- a. Connect the Type 284 Square Wave Output signal to the Type S-4 as shown in Fig. 4-1. Use a 2 \times GR attenuator at the Type 284 Output connector and a GR to 3 mm adapter to the Type S-4 input connector.
- b. Check the CRT for a normal square wave display. If the display is normal, proceed to step 3. If there is no display, perform step 2.

2. Check Strobe Operation

- a. Remove the extender cable from the sampling head (the indicator oscilloscope power may be left on).
- b. Remove the Type S-4 case. First, remove the four round-head screws, visible at the back casting, then slide the cover off by gently pulling it away from the front casting and input connector.
- c. Reconnect the extender cable to the Type S-4. Use care to properly align the Trigger Pickoff connector.
- d. Check for proper strobe operation by connecting a $10\times$ probe from the test oscilloscope to the emitter of Avalanche transistor Q69. Amplitude of the waveforms is affected by adjustment of Avalanche Volts control R66. Check the waveforms at the collector of Q69 and at the Primary of T75 (Pin E of the Strobe Board). Typical displays are shown in Fig. 4-2.

3. Adjust Avalanche Volts and Snap-Off Current

Avalanche Volts control R66 alters the strobe pulse amplitude and risetime. These affect the display noise, balance,

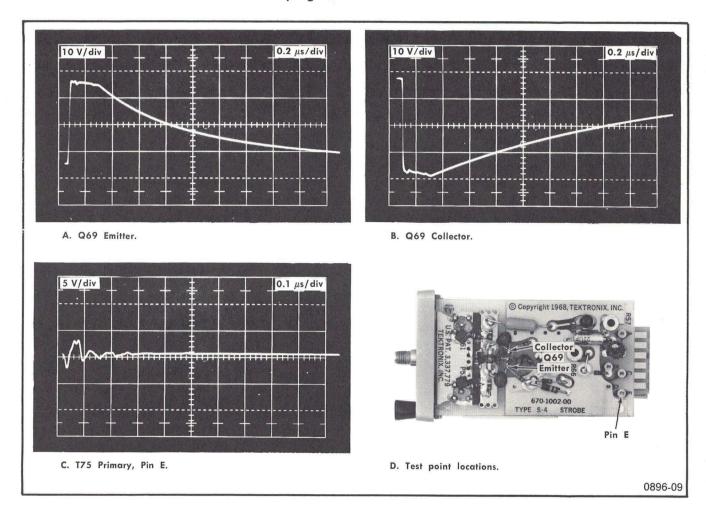


Fig. 4-2. Typical displays for Q69 operation.

and dot transient response. Snap-Off control R57 affects display noise, balance, and strobe kick-out.

- a. Disconnect the $2\times$ GR attenuator from the Type 284. Leave the attenuator and adapter attached to the Type S-4.
- b. Set the Type 7T11 Trigger Sensitivity control for a free-running trace.
- c. Set Avalanche Volts control R66 (see Fig. 4-3) and Snap-Off Current control R57 to midrange.
- d. Turn the Avalanche Volts control R66 clockwise into the free-run position. The trace will become very noisy. Turn R66 counterclockwise about $30\,^\circ$ or more from the free-run position.

- e. Set Snap-Off Current control R57 for the minimum amount of current to center the trace on the CRT. This will appear as the first nulling as the trace moves on the CRT with clockwise rotation of R57.
- f. Fine adjustment of the controls is made for maximum loop gain and best dot transient response linearity. Connect the Type 284 Square Wave Output to the Type S-4 Input connector through the $2\times$ attenuator and 3 mm to GR adapter.
- g. Set the sampling sweep unit to Int. Trig. and the sweep rate to 20 ns/div and obtain a double triggered display. The display may show greater than unity loop gain as a double trace. See Fig. 4-5.
- h. Set the Avalanche Volts, R66, and the Snap-Off Current, R57, controls for maximum loop gain (two traces on

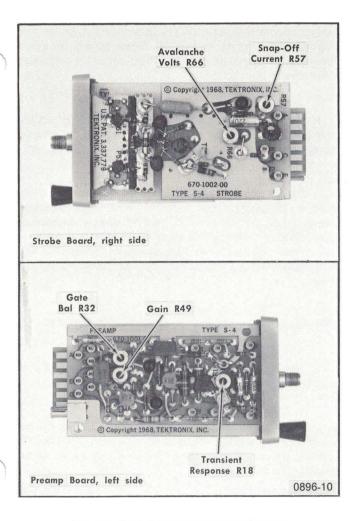


Fig. 4-3. Type S-4 internal control locations.

the square wave) and linearity (difference at upper and lower trace separations should be equal).

i. Disconnect the $2\times$ attenuator from the Type 284 and Type S-4.

4. Check or Adjust Strobe Kickout

NOTE

Strobe kickout needs to be checked only if the Sampling Gate substrate assembly or Strobe Board have been replaced or R57 or R66 has been adjusted.

a. Install the extender in the 7S11 and attach the Type S-4. Connect the Type S-4 Input connector through a 3 mm to GR adapter to the sampling test oscilloscope.

Performance Check and Calibration—S-4 Sampling Head

- b. Connect the Type 284 Trigger Output to the indicator oscilloscope sampling sweep unit Trigger Input 50 Ω connector with a BNC cable. Set the Type 284 Mode switch to Pulse Output.
- c. Connect the 7T11 Pulse Out connector through a BNC cable to the External Trigger Input 50 Ω connector on the sampling test oscilloscope.
- d. Set the indicator oscilloscope sampling sweep unit controls as follows:

Time Position
Time/Div
Range
So ns
Display Mode
Manual Scan
Trigger Sensitivity
Stability
Polarity

Midrange
Manual
Manual
Midrange
Fully clockwise
Fully counterclockwise
Fully counterclockwise

Trig Ext 50 Ω

e. Set the sampling test oscilloscope as follows:

Sampling Sweep Unit

Time/Div 5 ns
Time Position Clockwise
Trigger Source Ext
Slope +
Sweep Mode Ref
Trigger Sensitivity 10 o'clock

Sampling Unit

Millivolts/Div 50
DC Offset Centered display
Other controls Optional

Adjust the indicator oscilloscope sampling sweeps $\underline{\mathsf{MAN}}$ $\underline{\mathsf{SCAN}}$ and $\underline{\mathsf{TIME}}$ $\underline{\mathsf{POSITION}}$ to display kickout on the sampling test oscilloscope.

- f. Set the indicator oscilloscope sampling unit Units/Div switch to 2 and rotate the DC Offset control. The sampling test oscilloscope CRT display should show a spike in the ringing portion, positive for counterclockwise rotation and negative for clockwise rotation. This identifies the Strobe kickout. Place the ringing portion in the first division with the Time Position/control, see Fig. 4-4.
- g. Change the sampling test oscilloscope sweep rate to 200 ps/div. Fig. 4-4 shows the sampling unit (1) DC Offset

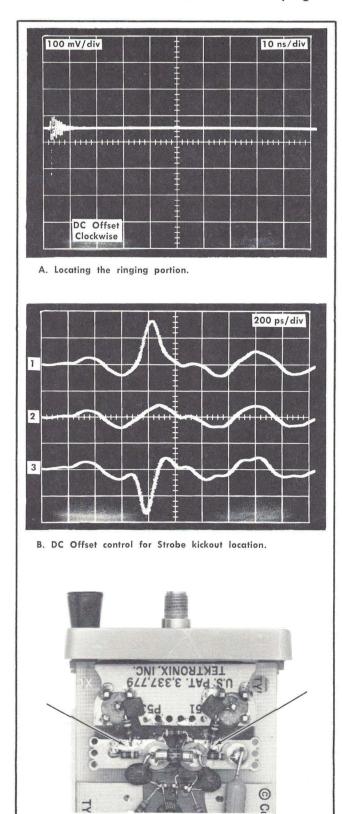


Fig. 4-4. Strobe kickout from the Type S-4 Input connector.

0896-11

C. Location of the solder points.

control counterclockwise, (2) DC Offset control set for minimum of both strobes, and (3) DC Offset control set clockwise. Set the indicator unit DC Offset control for minimum amplitude of both strobes.

- h. Set the indicator sampling unit Units/Div switch to 100 and check the kickout. Amplitude up to a 50 mV peak is acceptable.
- i. Reduce the kickout amplitude by moving the solder point on the clipping lines of R51 or R53. Since the solder points are at ground potential, the CRT display is observed as the lead is heated with a small soldering iron and moved with a soldering tool. Keep the solder points as close to R50 as possible. Fig. 4-4 shows the solder points on the clipping lines.
 - j. Set the sampling test oscilloscope at 1 ns/div.
- k. Set the indicator oscilloscope sampling unit Units/Div switch to 2 and the DC Offset control fully clockwise.
- I. Check that the kickout occurs within 1.2 ns of the beginning of the ringing portion. If not, readjust the Snap-Off Current control. To place the kickout within 1.2 ns of the beginning of the ringing.

The case on the Type S-4 may change the kickout amplitude from that observed with the case off. Desired minimum is with the case on the Type S-4 and several attempts may have to be made.

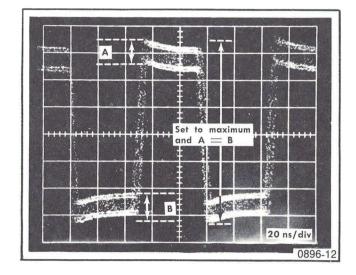


Fig. 4-5. Fine adjustment of Avalanche Volts and Snap-Off Current.

5. Adjust Gate Bal

Gate Bal control R32 introduces an internal offset voltage to the feedback loop to cancel normal error signals in the sampling loop, including normal unbalance in the traveling wave gate. R32 is adjusted (with DC Offset at zero) to cancel most of the vertical trace shift as the Units/Div switch setting is changed.

- a. Set the sampling unit DC Offset control for zero volts at the Offset Out jack.
- b. Observe the trace as the sampling unit Units/Div switch is operated through its ranges and adjust Gate Bal control R32 for no more than one division of vertical shift of the trace. This adjustment varies with changes in the extender cable and when the Type S-4 case is removed or replaced. The Gate Bal control should be readjusted each time the equipment configuration is changed (cable moved or Type S-4 cover removed or replaced).
 - c. Set the sampling unit Units/Div switch to 100.

6. Check Dot Transient Response

Requirement—Dot will move full amplitude $\pm 5\%$, of any signal up to 500 mV peak to peak when sampling sweep unit is either double triggered or free run.

- a. Connect the Type 284 Square Wave Output connector to the Type S-4 input connctor with the $2\times$ GR attenuator or variable attenuator and 3 mm to GR adapter.
- b. Connect the coaxial cable from the Type 284 Trigger Output to the sampling sweep Trigger Input connector.
- c. Set the Type 284 Period switch to 100 ns sampling. Set the 7T11 Range switch to .5 μ s, the Time/div to 20 ns.
- d. Set the sampling unit Units/Div switch to 100 and free run the sampling sweep unit at 0.5 μ s/div.
- e. Set the sampling unit Dot Response so the top of the square wave is at unity loop gain (one trace). The bottom of the square wave can show two traces, but the dot response overshoot or undershoot must not be greater than 5%, or 0.25 major division on the graticule (see Fig. 4-6).

If the dot response overshoots or undershoots more than 5%, perform step 7 (perform Step 7 for a complete recalibration.)

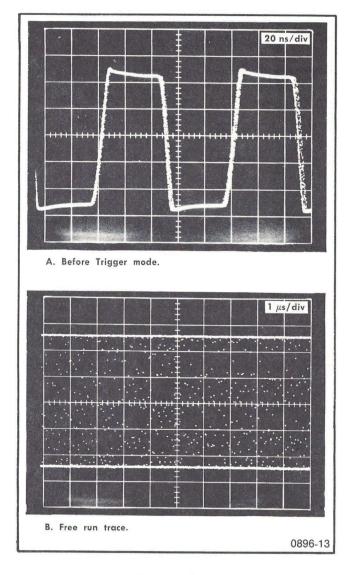


Fig. 4-6. Dot Transient Response check.

7. Adjust Gain

Gain control R49 changes the feedback loop gain.

- a. Use the same setup as the preceding steps. Set the sampling unit Dot Response control to its electrical midpoint. The electrical midpoint is found by watching the changes in the display with greater or less than unity loop gain and setting the Dot Response control half-way between maximum loop gain and minimum loop gain.
- b. Adjust Gain control R49 for unity loop gain as shown in Fig. 4-6.

Fine adjustment of Avalanche Volts control R66 and Snap-Off Current control R57 for the best dot transient re-

Performance Check and Calibration—S-4 Sampling Head

sponse with minimum noise may correct a dot response overshoot or undershoot in excess of the 5% tolerance. Sampling gate replacement may cause unbalanced response. See step 4 for adjustment of strobe pickoff resistors R51 and R53.

8. Check Maximum Operating Signal Voltage

Requirement—Signal amplitude up to 1 V peak to peak must be displayed without distortion.

- a. Connect the Type 284 Square Wave Output to the Type S-4 through a 3 mm to GR adapter and the solid coaxial 3 mm line.
- b. Connect the Type 284 Trigger Output to the sampling sweep Trigger Input.
- c. Set the sampling unit Units/Div switch to 20. Set the Type 284 Period switch to 1 μs and the Amplitude switch to 100 mV.
- d. Set the sampling sweep unit for a 200 ns/div sweep, and obtain a stable display. Observe the top and bottom portions of the display.
- e. Change the Units/Div switch to 200 and the Type 284 Amplitude switch to 1.0 V.
- f. Check that the square wave display is not distorted at the top or bottom portions as observed in part d.

A distorted Square Wave display may be caused by Gate unbalance. Check step 5, Adjust Gate Bal, or replace the substrate assembly, see the Maintenance section.

g. Remove the 3 mm GR adapter and the solid coaxial 3 mm line.

9. Check Displayed Noise (Tangential)

NOTE

When making a visual noise reading from a sampling display, the eye interprets a noise value which is neither the RMS nor the peak-to-peak value. Since most observers agree that the displayed noise value is approximately 3 times the RMS value, the Tangential Noise here defined is 3 times the RMS value. (The measurement technique given produces acceptable agreement between various operators as to the instrument's noise value.)

Requirement—Tangential noise will be not greater than 5 mV, with the case on the Type S-4.

- a. Connect the Type 284 Square Wave Output to the Type S-4 Input connector with the $2\times$ GR attenuator, variable attenuator, and the 3 mm to GR adapter. Set the 284 to 100 mV and 100 ns period.
- b. Set the sampling unit Units/Div switch to 10 and the Variable control to Cal.
- c. Set the 7T11 sweep range to 5 μ s, the time/div to .5 μ s sweep and the Trigger Sensitivity control clockwise for free run operation. Disconnect the coaxial cable to the Trigger Input connector.
- d. Refer to Fig. 4-7 for displays of the following noise measurement procedure.
 - (1) Obtain a display of two traces.
 - (2) Adjust the variable attenuator until the two traces blend together just to the point at which they appear as one trace.
 - (3) Change the Type 284 Amplitude switch to 1.0 V, 10 times the signal amplitude. The display now has tangential deflection factor of 1.5 mV/div.

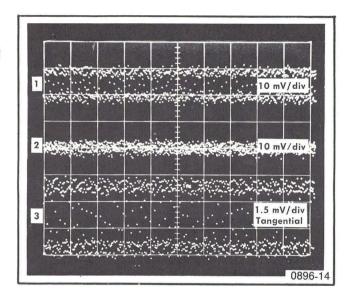


Fig. 4-7. Triple exposure of Tangential noise measurement.

Tangential deflection factor per division is equal to the Units/Div setting of 10 mV divided by 2, times 3 divided by 10 = 1.5 mV/div.

The 5 mV tangential display noise limit includes 3.33 graticule divisions (3) of Fig. 4-7. Check that the bottom edges of the two traces are not more than 3.33 divisions apart. Waveform (3) measures as 3.6 mV tangential noise.

Determining Tangential Noise Deflection Factor.

The noise displays of Fig. 4-7 have a noise deflection factor based upon the signal amplitude, the sampling unit Units/Div setting, the fact that the final trace separation is twice the RMS noise, and that the tangential noise is 3 times the RMS noise. The square wave signal amplitude that makes two traces appear as one sets the trace separation to twice the RMS noise. The procedure used here then permits a noise deflection factor to be determined by dividing the input mV/div deflection factor by 2 (trace separation is 2 times the RMS noise), multiplying by 3 (tangential noise is 3 times the RMS noise) and then dividing by 10 (the signal amplitude change factor).

e. Disconnect the Type S-4 from the Type 284.

10. Check Risetime

Requirement—The 10% to 90% risetime is equal to or less than 25 ps, displayed as 35 ps or less using the Type S52 Pulse Generator Head.

Risetime measurement requires either a camera or a storage oscilloscope because the dot density must be in-

Performance Check and Calibration—S-4 Sampling Head

creased for an accurate display and the sweep becomes too slow for visual interpretation.

Install another 7S11 in the left vert.

- a. Install the Type S-4 in the sampling unit right 7S11 without the extender.
 - b. Set the sampling unit Units/Div switch to 100.
- c. Connect the Type S-52 on the extender in the left 7S11 sampling unit. Connect the Pulse Output to the rigid coaxial line and to the Type S-4 Input connector. Connect the BSM to BNC cable from the Type S-52 Petrig Out connector to the sampling sweep unit 50 Ω Trigger Input connector.
- d. Set the sampling sweep unit for a 10 ps/div sweep rate (Range switch to 50 ns, Time/div switch to 10 ps. Center the rising portion of the pulse on the graticule and obtain at least 100 dots per division. Photograph or store the display.
 - e. Measure the risetime as follows:
 - (1) Mark reference points at maximum rate of change, the break points shown in Fig. 4-8.
 - (2) Mark the centers of the 0% zone and 100% zone (the specified system risetime, 35 ps), 35 ps from the reference break points, shown in Fig. 4-8.
 - (3) mark the average level of the 0% and 100% zones through the centers of the zones.

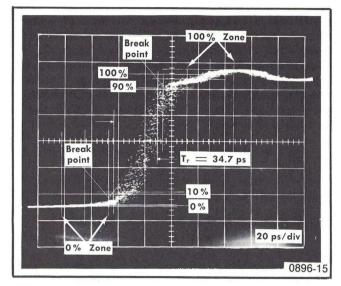


Fig. 4-8. Combination of Type S-4 and Type S-52 risetime measurement.

Performance Check and Calibration—S-4 Sampling Head

- (4) Mark the 10% and 90% points in relation to the 0% and 100% average levels.
- (5) Measure the risetime between the 10% and 90% points.
- f. Check that the risetime is 35 ps or less.
- g. Use the same display and setup for the pulse flatness deviation check, step 10.

11. Check Pulse Flatness Deviation

Requirement—Pulse will deviate from the flat;

First 400 ps after step, -10%, +10% or less, total less than 20% peak to peak;

Between 400 ps and 25 ns after step, 0%, +10% or less, total less than 10% peak to peak;

After 25 ns, +2%, -2% or less, total less than 4% peak to peak.

The Type S-52 is used to determine pulse flatness deviation during the first 400 ps and the Type 284 is used after the first 400 ps.

Measurement of the pulse flatness deviation during the first 400 ps requires either a camera or a storage oscilloscope because the dot density must be increased for an accurate display and the sweep becomes too slow for visual interpretation, as in the check of risetime.

- a. Use the same setup as in step 10 and set the 100% zone on a graticule line. Change the sampling sweep unit sweep rate to 50 ps/div and Time Position the display so the 90% amplitude point is near the first division on the graticule.
- b. Check that the pulse does not deviate from the 100% level more than +10% or -10% (total of 20% peak to peak) during the first 400 ps, see Fig. 4-9A. 10% is a half division.
 - c. Disconnect the Type 52 from the rigid coaxial line.
- d. Connect the Type 284 Pulse Output connector to the Type S-4 Input connector through a 3 mm to GR adapter and the 3 mm rigid coaxial line. Set the Type 284 Mode switch to Pulse Output. Connect the Type 284 Trigger Output to the sampling sweep unit 50 Ω Trigger Input connector through a BNC coaxial cable.

- e. Set the sampling sweep unit sweep rate to 100 ns/div (Range switch to 5 μ s, Time/div to 100 μ s push random button and obtain a stable display.
- f. Use the sampling sweep unit Time Position control to place the rising portion of the pulse one division from the left edge of the graticule. Set the sampling unit Variable Units/Div control for 5 divisions between the 0% amplitude and the 100% amplitude level. See Fig. 4-9B. Use the point 50 ns before the pulse as 0% and the point 500 ns after the pulse as 100%.
- g. Change the Units/Div switch (without moving the Variable control) to 20 or a signal amplitude now 4% per division.
- h. Position the trace bottom at the 100% (500 ns after pulse rise) amplitude point on the center graticule line.
- i. Check the pulse flatness deviation from 25 ns after pulse rise through end of the pulse. (The Time Position control may be used.) See Fig. 4-9C.
- j. Check that the pulse flatness deviation is not more than +2%, -2% (total of 4% peak to peak). If the deviation is more than specified, perform step 12, Adjust Transient Response.
 - k. Set the sampling sweep unit sweep rate to 5/ns.
- I. Reposition the rising portion of the pulse one division from the left edge of the graticule. Check the pulse flatness deviation from 400 ps to 25 ns after the pulse rise. See Fig. 4-9D.
- m. Check that the pulse flatness deviation is not more than 0%, +10% or total 10% peak to peak. Use the same setup to perform the Transient Response adjustment. If the pulse flatness deviation is within specifications, disconnect the Type 284 with the rigid coaxial line from the Type S-4 and remove the BNC coaxial cable from the sampling sweep Trigger Input and proceed to step 13.

12. Adjust Transient Response

Transient Response control R18 adjusts the magnitude of the blow-by correction signal; it does not change risetime.

a. Use the same setup as the pulse flatness deviation check, parts d through j.

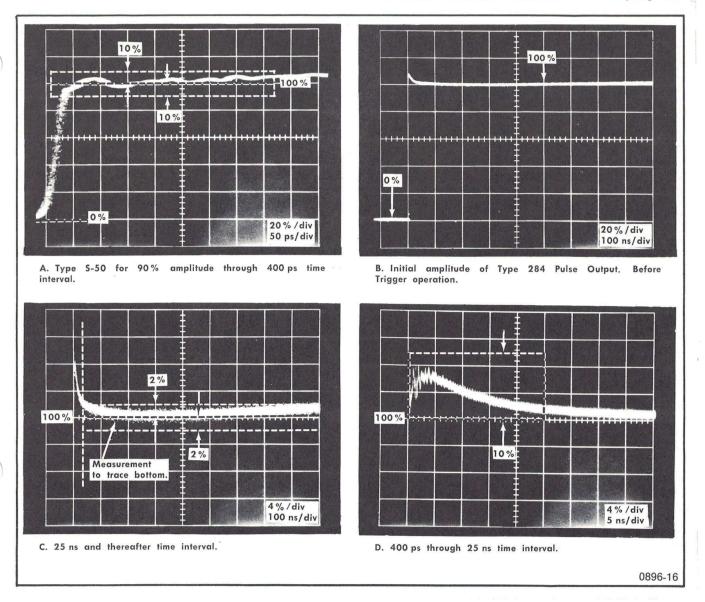


Fig. 4-9. Check of pulse flatness deviation.

- b. Adjust Transient Response R18 so the pulse flatness does not deviate more than +2% or -2%, total 4% peak to peak, in the interval following 25 ns after the pulse rise. See Fig. 4-9C.
- c. Disconnect the Type 284 with the rigid coaxial line from the Type S-4 Input and remove the BNC coaxial cable to the sampling sweep unit Trigger Input connector.

13. Check Baseline Shift With Repetition Rate Change

Requirement—A no signal-trace will not shift vertically more than 10 mV when the sampling sweep unit external trigger rate is changed from 30 Hz to 50 Hz.

a. Use the test oscilloscope as a trigger rate generator. Drive the sampling sweep unit external trigger input with the front panel +Gate signal (+20 volts peak). Connect the +Gate to the Type 7T11 connector and trigger on the - polarity of the signal.

Set the test oscilloscope sweep controls for a free run sweep. To obtain a 30 Hz trigger signal, set the Time/Div switch to 2 ns and the Variable time/div control to a position about mid range. To obtain a 50 kHz trigger signal, set the Time/Div switch to 20 μ s and the Variable time/div control to a position midrange.

b. Connect the 3 mm to GR adapter and $2\times$ GR attenuator on the Type S-4 Input connector.

Performance Check and Calibration—S-4 Sampling Head

- c. Set the sampling sweep unit for an external triggered sweep rate of 50 ns/div (to ensure that the shortest trigger circuit holdoff period is obtained and that the triggering rate can actually follow the external triggering signal repetition rate).
- d. Set the sampling unit Units/Div switch to 10. Connect the external trigger rate generator signal to the sampling sweep unit and obtain a triggered sweep at either 30 Hz or 50 kHz repetition rate. Set the sampling unit DC Offset control to place the trace at one of the graticule lines.
- e. Change the trigger rate generator through its ranges to the other frequency limit and check that the CRT trace does not move up or down farther than a total of one division.
- f. If the trace moves too far, check the avalanche transistor, Q69. This requires starting the procedure at step 1.
- g. Disconnect the Trigger Input cable from the test oscilloscope.

MAINTENANCE

Introduction

This section is a maintenance guide for the Type S-4 Sampling Head. Some circuit testing and repair suggestions are included. See the Circuit Description for additional circuit details if a problem exists that is not covered here. Parts ordering, disassembly and reassembly information is also included.

To remove the Type S-4 Sampling Head from its case, loosen the four retaining screws on the back. Then slide the back off and remove the case by sliding it to the rear. Directions for replacing the case will be found at the end of this section.

Parts Removal and Replacement

All parts used in the Type S-4 can be purchased directly through your Tektronix Field Office or Representative, although standard electronic items may be obtained locally. Replacements for the special parts used in the Type S-4 should be ordered from Tektronix since these parts are either manufactured or selected by Tektronix to satisfy a particular requirement. Before purchasing or ordering, consult the Electrical or Mechanical Parts List to determine the value, tolerance and ratings required.

NOTE

When selecting the replacement parts, it is important to remember that the physical size and shape of a component may affect its performance at high frequencies. Parts orientation and lead dress should duplicate those of the original part since many of the components are mounted in a particular way to reduce or control stray capacitance and inductance. After repair, the sampling head may require calibration.

Transistor Replacement. Cut the leads of a replacement transistor to the same length as the transistor removed and bend the leads as necessary. The lead configurations of the transistors used in the Type S-4 are shown in Fig. 5-1. Two transistors on the Trigger Amp circuit board (Q10 and Q14) have soldered leads. Field-effect transistor Q36 mounting has an arrow at the tab position.

Leadless Capacitors. There are leadless ceramic capacitors soldered directly to the circuit board. Care must be taken when replacing these capacitors as they crack easily. The type of solder used must be electronic grade 60/40 or 63/38 solder with good cold-flow characteristics.

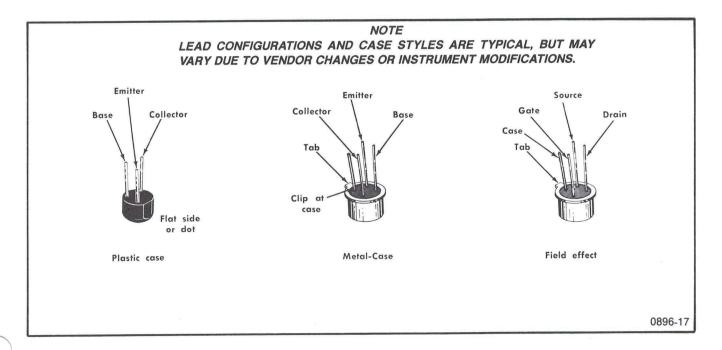


Fig. 5-1. Lead configuration of transistors in the Type S-4.

Maintenance—S-4 Sampling Head

Solder the leadless capacitor into place by positioning the part and applying heat to the adjacent plated area. Solder leads to the leadless capacitor by applying heat to the leads. Excess solder on either side of the capacitor can lead to a shorted circuit.

Removal and Replacement of Snap-off Diodes. The Snap-off diode is mounted in small metal clips, as shown on the circuit board illustration.

Circuit Board Replacement. If a circuit board is damaged and cannot be repaired, the entire assembly including all soldered-on components should be replaced. The part number given in the Mechanical Parts List is for the completely wired board.

The Strobe Board and the Preamp Board are removed by gently pulling outward from the Sampler Board. The Preamp Board holds the pretrigger output connector, P17, and a coaxial cable from the Trigger Amp Board soldered to the junction of R17 and R18. For replacement, align the connectors and pin contacts and ease the boards into position. Pin connectors should not protrude beyond the clamps.

Remove the Sampler Board as in Fig. 5-2 and as follows:

- 1. Loosen, but do not remove, the threaded nut on the Input connector with a 5/16 inch wrench.
- 2. Loosen the Input connector with a 7/32 inch wrench. Remove the Input connector with the fingers.
- 3. Unsolder the $-12.2\,\mathrm{volt}$ lead to the Trigger Amp Board.
- 4. Loosen, but do not remove, the 5/16 nut holding the Trigger Amp Board. The Trigger Amp Board is wired to the Sampler Board and to the Preamp Board.
- 5. Remove the attenuator by unscrewing it from the substrate assembly (right hand thread) and then slide both the attenuator and the Trigger Amp Board to the rear.
- 6. Remove the substrate assembly, bracing it with a finger as in Fig. 5-2B, by removing the hexagonal screws with a 3/64 inch Allen wrench. Lift the substrate assembly away from the Sampler Board.

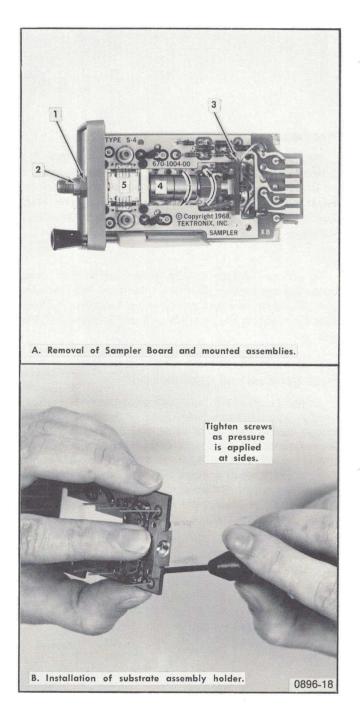


Fig. 5-2. Sampler Board removal and reassembly.

NOTE

Do not touch the gold plated areas on the substrate, which are visible at the sides, due to the possibility of contamination from natural body oils.

Replacement of the mounted assemblies and the Sampler Board follows:

- 1. Place the substrate assembly on the Sampler Board between the pins, which prevent forward or backward movement, and brace the substrate assembly as the hexagonal screws are screwed in approximately half a turn. Apply pressure at the Sampler board sides, see Fig. 5-2B, and tighten the front screws. The substrate should orient itself for best electrical contact. Then tighten the rear screws and release the pressure.
 - 2. Install the attenuator and Trigger Amp Board.
- 3. Tighten the coupling nut. Solder the -12.2 volt lead to the board. The Preamp Board may be placed into position at this time.
- 4. Place the front panel so the Input connector will align with the substrate assembly. Make sure the plastic locking pawl is positioned with the flat surface facing downward. Finger tighten the connector. Tighten the Input connector with a 7/32 inch wrench to 10 in-lbs, estimated, if no torque wrench is available. Tighten the locking nut with a 5/16 inch wrench to 15 in-lbs.

Replacement of the Sampling Gate substrate assembly or of the Strobe Board may cause a system unbalance, resulting in strobe kickout from the Input connector. This condition is corrected by resoldering R51 or R53 (possibly both) to a different point on the clipping lines. See the Performance Check/Calibration Procedure.

Checking Sampling Gate Diodes

A dynamic check of the condition of the forward characteristics of the sampling gate diodes can be quickly made by following the procedure outlined in Section 4, step f, of this manual. In this check, the diodes are checked for both + and - strobe pulse conduction. If either the + or the - strobe pulse is not found in this dynamic check, then further static checks can be performed on the gate, as outlined below. If both strobe polarities are observed, the other circuits of the sampling head should be checked for problems, leaving the sampling gate till last.

The Sampling Gate diodes can be specially checked by the use of a transistor characteristic curve tracer, such as the Tektronix Type 576. DO NOT USE AN OHMMETER TO CHECK THE SAMPLING GATE DIODES.

Once it has been decided to check the Sampling Gate diodes, refer to Fig. 5-3 for both the Sampling Gate circuit and test points used in the procedure listed below. The pro-

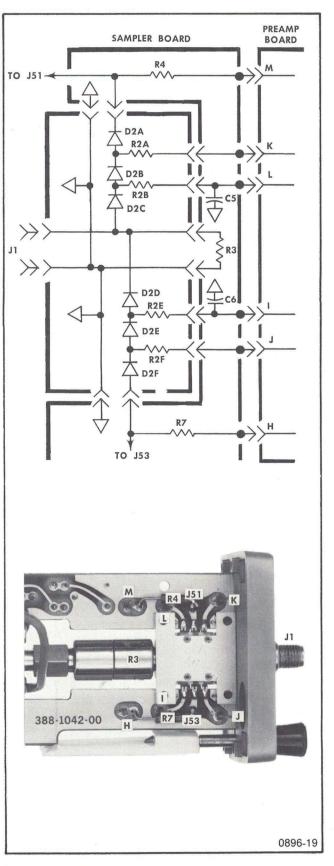


Fig. 5-3. Sampling Gate circuit and test points for checking the diodes.

Maintenance—S-4 Sampling Head

cedure outlines a method of checking forward conduction in groups of three, and reverse leakage on an individual basis.

- 1. Remove the sampling head case and the Preamplifier board. Leave the attenuator and Strobe Board in place.
- 2. Refer to Fig. 5-3 for testpoints that must be used for checking D2A, D2B and D2C in one group of D2D, D2E and D2F in a second group. For the first group, the curve tracer positive lead is to be attached to J53. Attach the negative lead of the first group to J51. When checking the second group ground the negative lead. These polarity connections test each group of three diodes for their forward conduction in the curve tracer first quadrant as shown in Fig. 5-4.
 - 3. Set the Type 576 controls:

Vertical Current

Collector MA

1 mA/Div

Horizontal Volts/Div

Collector Volts

Peak Volts

15

Polarity

VARIABLE COLLECTOR

For no-load 5 divisions

SUPPLY

140 Ω

Dissipation Limiting Resistor

Base Step Generator

Controls

Optional, not used.

Sloping Panel Controls

Grounding Sw

Emitter Grounded

Selector Sw

Left or Right, whichever side has had clip leads

attached for the test.

Both Position

Dot at Graticule

Controls

center.

- 4. Attach two leads to terminals of the Type 576 sloping front panel. Small clip leads or meter leads with banana tips on one end and prongs on the other end will do. Attach one lead to an E connection and the other to the C connection above the E post. Place the selector switch so it points toward the side where the test leads are connected.
- 5. Connect the E lead to the Sampling Gate terminal J51 and the C lead to ground. The Type 576 display should now be like the first quadrant display of Fig. 4-4. If the display shows slightly more than 1.2 volts flat display and then a rising portion like Fig. 5-4, the three diodes D2A, D2B and D2C are operating correctly in the forward direction. Check

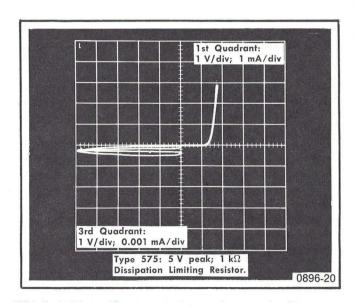


Fig. 5-4. Type 576 Characteristic curves of forward and reverse voltage conduction of D2A, D2B and D2C. Do not use more than 5 volts peak.

the other three diodes forward conduction before measuring either set reverse leakage.

- 6. Move the test leads so the E lead is touching the sampling head ground and the C lead is touching J53. The display should be the same as that in the first quadrant of Fig.
- 7. To check the reverse leakage of a diode, change the Type 576 controls:

Vertical Current

Collector mA

 $1 \mu A$

Vertical Position

No-load trace at

graticule centerline.

Applied Voltage Polarity

8. The set-up of part 7 gives a vertical deflection factor of 0.001 mA/Div, and will probably include some hum loops as shown in the third quadrant of Fig. 5-4.

Connect the leads to check each individual diode reverse leakage. Checking reverse leakage of three in series might not given an indication that one is bad. Any one diode that shows any discernible leakage (negative movement of Type 576 trace) is cause to reject a whole Sampling Gate assembly.

Test points are listed in Table 5-1 for all six diodes.

Table 5-1
Individual Sampling Gate diode test terminals for reverse leakage checking

Diode	Terminals + –		
D2A	J51	К	
D2B	K	L	
D2C	L	Ground	
D2D	Ground	1	
D2E	L	J	
D2F	J	J53	

Major Circuits and Parts Locations

The remainder of this section includes photographs of sections of the Type S-4. Major circuit ares are identified. All components mounted on circuit boards are identified by circuit numbers.

Replacing the Sampling Head Case

To replace the case on the sampling head, align the body so that the hole in the side appears over the Gate Bal control at the rear of the Preamp Board. Check that the upper and lower corners of the Preamp and Strobe boards are aligned with the channels in the sampling head body which contain the zigzag springs. Push the body gently forward until it contacts the front panel. In attaching the rear casting, be sure that the hole at one side of the casting fits over the trigger pickoff signal output connector. Insert the four long mounting bolts and tighten them securely.

Repackaging for Shipment

If the Tektronix instrument is to be shipped to a Tektronix Service Center for service or repair, attach a tag showing: owner (with address) and the name of an individual at your firm that can be contacted, complete instrument serial number and a description of the service required.

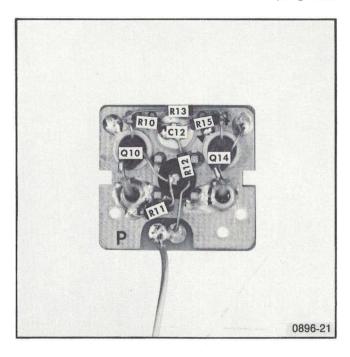


Fig. 5-5. Trigger Amp circuit board.

Save and re-use the package in which your instrument was shipped. If the original packaging is unfit for use or not available, repackage the instrument as follows:

Surround the instrument with polyethylene sheeting to protect the finish of the instrument. Obtain a carton of corrugated cardboard of the correct carton strength and having inside dimensions of no less than six inches more than the instrument dimensions. Cushion the instrument by tightly packing three inches of dunnage or urethane foam between carton and instrument, on all sides. Seal carton with shipping tape or industrial stapler.

The carton test strength for your instrument is 200 pounds.

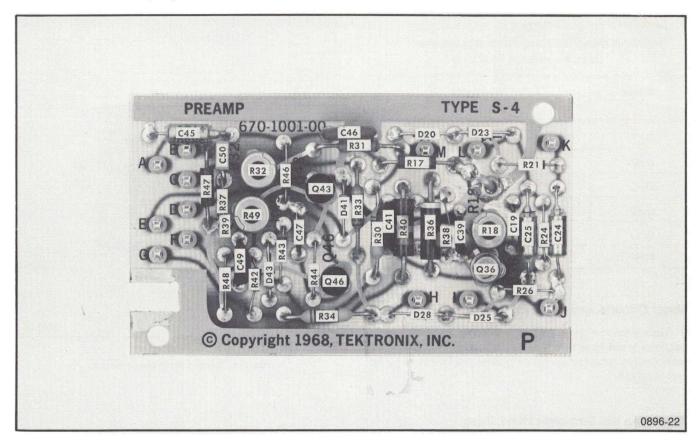


Fig. 5-6. Preamp circuit board.

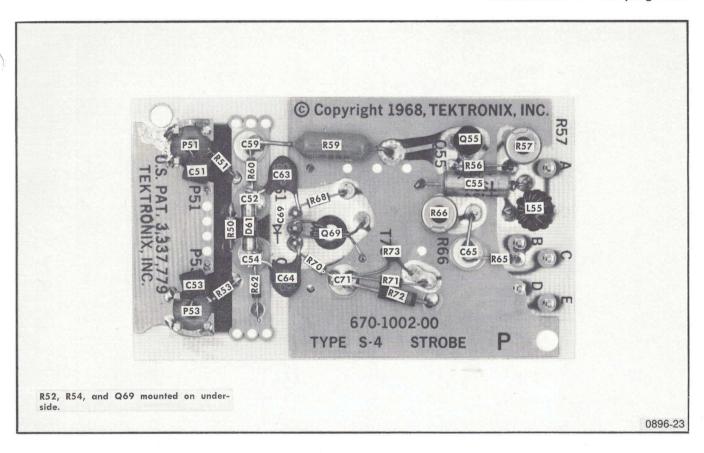


Fig. 5-7. Strobe circuit board.

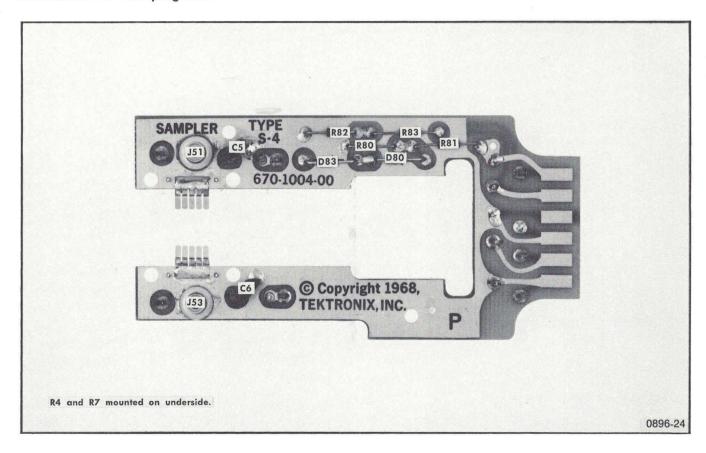


Fig. 5-8. Sampler circuit board.

OPTIONS

There are no options at this time.

REPLACEABLE ELECTRICAL PARTS

PARTS ORDERING INFORMATION

Replacement parts are available from or through your local Tektronix, Inc. Field Office or representative.

Changes to Tektronix instruments are sometimes made to accommodate improved components as they become available, and to give you the benefit of the latest circuit improvements developed in our engineering department. It is therefore important, when ordering parts, to include the following information in your order: Part number, instrument type or number, serial number, and modification number if applicable.

If a part you have ordered has been replaced with a new or improved part, your local Tektronix, Inc. Field Office or representative will contact you concerning any change in part number.

Change information, if any, is located at the rear of this manual.

LIST OF ASSEMBLIES

A list of assemblies can be found at the beginning of the Electrical Parts List. The assemblies are listed in numerical order. When the complete component number of a part is known, this list will identify the assembly in which the part is located.

CROSS INDEX-MFR. CODE NUMBER TO MANUFACTURER

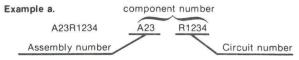
The Mfr. Code Number to Manufacturer index for the Electrical Parts List is located immediately after this page. The Cross Index provides codes, names and addresses of manufacturers of components listed in the Electrical Parts List.

ABBREVIATIONS

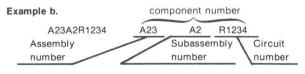
Abbreviations conform to American National Standard Y1.1.

COMPONENT NUMBER (column one of the Electrical Parts List)

A numbering method has been used to identify assemblies, subassemblies and parts. Examples of this numbering method and typical expansions are illustrated by the following:



Read: Resistor 1234 of Assembly 23



Read: Resistor 1234 of Subassembly 2 of Assembly 23

Only the circuit number will appear on the diagrams and circuit board illustrations. Each diagram and circuit board illustration is clearly marked with the assembly number. Assembly numbers are also marked on the mechanical exploded views located in the Mechanical Parts List. The component number is obtained by adding the assembly number prefix to the circuit number.

The Electrical Parts List is divided and arranged by assemblies in numerical sequence (e.g., assembly A1 with its subassemblies and parts, precedes assembly A2 with its subassemblies and parts).

Chassis-mounted parts have no assembly number prefix and are located at the end of the Electrical Parts List.

TEKTRONIX PART NO. (column two of the Electrical Parts List)

Indicates part number to be used when ordering replacement part from Tektronix.

SERIAL/MODEL NO. (columns three and four of the Electrical Parts List)

Column three (3) indicates the serial number at which the part was first used. Column four (4) indicates the serial number at which the part was removed. No serial number entered indicates part is good for all serial numbers.

NAME & DESCRIPTION (column five of the Electrical Parts List)

In the Parts List, an Item Name is separated from the description by a colon (:). Because of space limitations, an Item Name may sometimes appear as incomplete. For further Item Name identification, the U.S. Federal Cataloging Handbook H6-1 can be utilized where possible.

MFR. CODE (column six of the Electrical Parts List)

Indicates the code number of the actual manufacturer of the part. (Code to name and address cross reference can be found immediately after this page.)

MFR. PART NUMBER (column seven of the Electrical Parts List)

Indicates actual manufacturers part number.

CROSS INDEX - MFR. CODE NUMBER TO MANUFACTURER

Mfr.			
Code	Manufacturer	Address	City, State, Zip Code
01121	ALLEN-BRADLEY CO	1201 SOUTH 2ND ST	MILWAUKEE WI 53204
03508	GENERAL ELECTRIC CO	W GENESEE ST	AUBURN NY 13021
04222	SEMI-CONDUCTOR PRODUCTS DEPT AVX CERAMICS DIV OF AVX CORP	19TH AVE SOUTH	MYRTLE BEACH SC 29577
04713	MOTOROLA INC	P O BOX 867 5005 E MCDOWELL RD	PHOENIX AZ 85008
05397	SEMICONDUCTOR GROUP UNION CARBIDE CORP MATERIALS SYSTEMS DIV	11901 MADISON AVE	CLEVELAND OH 44101
07263	FAIRCHILD CAMERA AND INSTRUMENT CORP SEMICONDUCTOR DIV	464 ELLIS ST	MOUNTAIN VIEW CA 94042
12954	MICROSEMI CORP	8700 E THOMAS RD P 0 BOX 1390	SCOTTSDALE AZ 85252
14193	CAL-R INC	1601 OLYMPIC BLVD	SANTA MONICA CA 90404
15454	AMETEK INC RODAN DIV	2905 BLUE STAR ST	ANAHEIM CA 92806
15801	FENWAL ELECTRONICS DIV OF KIDDE WALTER AND CO INC	63 FOUNTAIN ST	FRAMINGHAM MA 01701
18203	ENGELMANN MICROWAVE CO	SKYLINE DRIVE	MONTVILLE NJ 07045
19701	MEPCO/ELECTRA INC A NORTH AMERICAN PHILIPS CO	P 0 B0X 760	MINERAL WELLS TX 76067
24931	SPECIALTY CONNECTOR CO INC	2620 ENDRESS PLACE P 0 BOX D	GREENWOOD IN 46142
26805	OMNI SPECTRA INC MICROWAVE CONNECTOR DIV	140 FOURTH AVE	WALTHAM MA 02154
32997	BOURNS INC TRIMPOT DIV	1200 COLUMBIA AVE	RIVERSIDE CA 92507
50101		16 MAPLE RD	SOUTH CHELMSFORD MA 01824
51642	CENTRE ENGINEERING INC	2820 E COLLEGE AVE	STATE COLLEGE PA 16801
57668	ROHM CORP	16931 MILLIKEN AVE	IRVINE CA 92713
59660	TUSONIX INC	2155 N FORBES BLVD	TUCSON, ARIZONA 85705
59821	CENTRALAB INC SUB NORTH AMERICAN PHILIPS CORP	7158 MERCHANT AVE	EL PASO TX 79915
71468	ITT CANNON ELECTRIC	10550 TALBERT PO BOX 8040	FOUNTAIN VALLEY CA 92728-8040
72982	ERIE TECHNOLOGICAL PRODUCTS INC	645 W 11TH ST	ERIE PA 16512
73138		2500 HARBOR BLVD	FULLERTON CA 92634
80009	TEKTRONIX INC	4900 S W GRIFFITH DR	BEAVERTON OR 97077
	****	P 0 BOX 500	
91418 98291	RADIO MATERIALS CORP SEALECTRO CORP	4242 BYRN MAWR AVE W 225 HOYT	CHICAGO IL 60646 MAMARONECK NY 10544

Component No.	Tektronix Part No.	Serial/Ass Effective		Name & Description	Mfr. Code	Mfr. Part No.
A1 A1	670-1001-00 670-1001-01	B010100 B072050	B072049	CIRCUIT BD ASSY:PREAMPLIFIER CIRCUIT BD ASSY:PREAMPLIFIER	80009 80009	670-1001-00 670-1001-01
A2 A2	670-1002-00 670-1002-01	B010100 B060000	B059999	CIRCUIT BD ASSY:STROBE CIRCUIT BD ASSY:STROBE	80009 80009	670-1002-00 670-1002-01
A3	670-1004-00			CIRCUIT BD ASSY:SAMPLER	80009	670-1004-00
A4	670-1003-00			CIRCUIT BD ASSY:TRIGGER TAKEOFF	80009	670-1003-00
A1 A1	670-1001-00 670-1001-01		B072049	CIRCUIT BD ASSY:PREAMPLIFIER CIRCUIT BD ASSY:PREAMPLIFIER	80009 80009	670-1001-00 670-1001-01
A1C19 A1C24 A1C25 A1C39	283-0136-00 290-0188-00 290-0267-00 283-0051-00			CAP, FXD, CER DI:10PF, 5%, 50V CAP, FXD, ELCTLT:0.1UF, 10%, 35V CAP, FXD, ELCTLT:1UF, 20%, 35V CAP, FXD, CER DI:0.0033UF, 5%, 100V	51642 05397 05397 04222	A100050-NPO-100J T322A104K035AS T320A105M035AS SR301A332JAA
A1C41 A1C45 A1C46 A1C47 A1C49 A1C50 A1C50	283-0000-00 290-0246-00 283-0005-00 283-0066-00 283-0000-00 283-0155-00 283-0005-00	B010100 B030000	B029999	CAP,FXD,CER DI:0.001UF,+100-0%,500V CAP,FXD,ELCTLT:3.3UF,10%,15V CAP,FXD,CER DI:0.01UF,+100-0%,250V CAP,FXD,CER DI:2.5PF,+/-0.5PF,200V CAP,FXD,CER DI:0.001UF,+100-0%,500V CAP,FXD,CER DI:0.01UF,10%,50V CAP,FXD,CER DI:0.01UF,+100-0%,250V	59660 12954 04222 72982 59660 04222 04222	831-610-Y5U0102P D3R3EA15K1 SR303E103ZAA 8101-047C0J259D 831-610-Y5U0102P 3418-050C-103K SR303E103ZAA
A1D20 A1D23 A1D25 A1D28 A1D41 A1D43	152-0333-00 152-0333-00 152-0333-00 152-0333-00 152-0141-02 152-0141-02			SEMICOND DVC,DI:SW,SI,55V,200MA,DO-35 SEMICOND DVC,DI:SW,SI,55V,200MA,DO-35 SEMICOND DVC,DI:SW,SI,55V,200MA,DO-35 SEMICOND DVC,DI:SW,SI,55V,200MA,DO-35 SEMICOND DVC,DI:SW,SI,30V,150MA,30V,DO-35 SEMICOND DVC,DI:SW,SI,30V,150MA,30V,DO-35	07263 07263 07263 07263 03508 03508	FDH-6012 FDH-6012 FDH-6012 FDH-6012 DA2527 (1N4152) DA2527 (1N4152)
A1Q36 A1Q43 A1Q46 A1R17 A1R18 A1R21	151-1012-00 151-0224-00 151-0224-00 315-0152-00 311-0643-00 317-0224-00			TRANSISTOR:FET,N-CHAN,SI,TO-72 TRANSISTOR:NPN,SI,TO-92 TRANSISTOR:NPN,SI,TO-92 RES,FXD,FILM:1.5K OHM,5%,0.25W RES,VAR,NONWW:TRMR,50 OHM,0.5W RES,FXD,CMPSN:220K OHM,5%,0.125W	04713 04713 04713 57668 32997 01121	SFD1012 SPS6917 SPS6917 NTR25J-E01K5 3329H-L58-500 BB2245
A1R24 A1R26 A1R30 A1R31 A1R32 A1R33	317-0393-00 317-0224-00 321-0385-00 321-0253-00 311-0609-00 321-0253-00			RES,FXD,CMPSN:39K OHM,5%,0.125W RES,FXD,CMPSN:22OK OHM,5%,0.125W RES,FXD,FILM:100K OHM,1%,0.125W,TC=TO RES,FXD,FILM:4.22K OHM,1%,0.125W,TC=TO RES,VAR,NONWW:TRMR,2K OHM,0.5W RES,FXD,FILM:4.22K OHM,1%,0.125W,TC=TO	01121 01121 19701 19701 32997 19701	BB3935 BB2245 5033ED100K0F 5033ED 4K 220F 3329H-L58-202 5033ED 4K 220F
A1R34 A1R36 A1R37 A1R38 A1R39 A1R40	321-0385-00 301-0912-00 317-0390-00 307-0127-00 307-0122-00 301-0103-00			RES,FXD,FILM:100K OHM,1%,0.125W,TC=TO RES,FXD,FILM:9.1K OHM,5%,0.5W RES,FXD,CMPSN:39 OHM,5%,0.125W RES,THERMAL:1K OHM,10% RES,THERMAL:50 HM,10%,NTC RES,FXD,FILM:10K OHM,5%,0.50W	19701 19701 01121 15801 14193 19701	5033ED100K0F 5053CX9K100J BB3905 JB-31J42 1B15-500K 5053CX10K00J
A1R42 A1R43 A1R44 A1R46 A1R47 A1R48	317-0224-00 317-0223-00 317-0122-00 317-0101-00 315-0272-00 317-0303-00			RES,FXD,CMPSN:220K OHM,5%,0.125W RES,FXD,CMPSN:22K OHM,5%,0.125W RES,FXD,CMPSN:1.2K OHM,5%,0.125W RES,FXD,CMPSN:100 OHM,5%,0.125W RES,FXD,FILM:2.7K OHM,5%,0.25W RES,FXD,CMPSN:30K OHM,5%,0.125W	01121 01121 01121 01121 57668 01121	BB2245 BB2235 BB1225 BB1015 NTR25J-E02K7 BB3035
A1R49 A1R49		B010100 B072050	B072049	RES, VAR, NONWW:TRMR, 10K OHM, 0.5W RES, VAR, NONWW:TRMR, 20K OHM, 0.5W	73138 32997	82-25-2 3329H-G48-203
A2	670-1002-00	B010100	B059999	CIRCUIT BD ASSY:STROBE	80009	670-1002-00

Component No.	Tektronix Part No.	Serial/Ass Effective		Name & Description	Mfr. Code	Mfr. Part No.
A2	670-1002-01	B060000		CIRCUIT BD ASSY:STROBE	80009	670-1002-01
A2C51 A2C52 A2C53 A2C54 A2C55	283-0154-00 283-0135-00 283-0154-00 283-0135-00 290-0134-00			CAP,FXD,CER DI:22PF,5%,50V CAP,FXD,CER DI:100PF,5%,500V CAP,FXD,CER DI:22PF,5%,50V CAP,FXD,CER DI:100PF,5%,500V CAP,FXD,ELCTLT:22UF,20%,15V	04222 91418 04222 91418 05397	SR155A22OJAA JK101J501959 SR155A22OJAA JK101J501959 T110B226M015AS
A2C59 A2C63 A2C64 A2C65 A2C69 A2C71	283-0121-00 283-0103-00 283-0103-00 283-0121-00 283-0140-00 283-0121-00			CAP,FXD,CER DI:1000PF,20%,200V CAP,FXD,CER DI:180PF,5%,500V CAP,FXD,CER DI:180PF,5%,500V CAP,FXD,CER DI:1000PF,20%,200V CAP,FXD,CER DI:4.7PF,+/-0.25PF,50V CAP,FXD,CER DI:1000PF,20%,200V	91418 59821 59821 91418 72982 91418	5P102M2011958 2DDH73L181J 2DDH73L181J 5P102M2011958 8101E003A479C 5P102M2011958
A2D61 A2D61 A2L55 A2P51 A2P53 A2Q55	152-0335-00 152-0335-01 120-0382-00 131-0582-00 131-0582-00 151-0224-00		B059999	SEMICOND DVC,DI:SNAP-OFF,SI SEMICOND DVC,DI:SNAP-OFF,SI,40V,DO-35 COIL,RF:210UH,+28%-43%,14 TURNS CONN,RCPT,ELEC:SNAP-ON,FEMALE,MODIFIED CONN,RCPT,ELEC:SNAP-ON,FEMALE,MODIFIED TRANSISTOR:NPN,SI,TO-92	80009 50101 80009 98291 98291 04713	152-0335-00 GC20279 120-0382-00 52-052-0049 52-052-0049 SPS6917
A2Q69 A2R50 A2R51 A2R52 A2R53 A2R54	153-0556-00 317-0470-00 317-0390-00 317-0101-00 317-0390-00 317-0101-00			TRANSISTOR:NPN,SI,SELECTED RES,FXD,CMPSN:47 OHM,5%,0.125W RES,FXD,CMPSN:39 OHM,5%,0.125W RES,FXD,CMPSN:100 OHM,5%,0.125W RES,FXD,CMPSN:39 OHM,5%,0.125W RES,FXD,CMPSN:100 OHM,5%,0.125W	04713 01121 01121 01121 01121 01121	SPS8830 BB4705 BB3905 BB1015 BB3905 BB1015
A2R56 A2R57 A2R59 A2R60 A2R62 A2R65	317-0271-00 311-0607-00 308-0243-00 317-0390-00 317-0390-00 317-0101-00			RES,FXD,CMPSN:270 OHM,5%,0.125W RES,VAR,NONW:TRMR,10K OHM,0.5W RES,FXD,WW:240 OHM,5%,3W RES,FXD,CMPSN:39 OHM,5%,0.125W RES,FXD,CMPSN:39 OHM,5%,0.125W RES,FXD,CMPSN:100 OHM,5%,0.125W	01121 73138 14193 01121 01121 01121	BB2715 82-25-2 SA31-2400J BB3905 BB3905 BB1015
A2R66 A2R68 A2R70 A2R71 A2R72 A2R73	311-0644-00 317-0332-00 317-0332-00 317-0202-00 315-0124-00 307-0124-00			RES, VAR, NONW: TRMR, 20K OHM, 0.5W RES, FXD, CMPSN: 3.3K OHM, 5%, 0.125W RES, FXD, CMPSN: 3.3K OHM, 5%, 0.125W RES, FXD, CMPSN: 2K OHM, 5%, 0.125W RES, FXD, FILM: 120K OHM, 5%, 0.25W RES, THERMAL: 5K OHM, 10%, NTC	32997 01121 01121 01121 19701 15454	3329H-G48-203 BB3325 BB3325 BB2025 5043CX120K0J 1DC502K-220-EC
A2T75	120-0544-00			XFMR,TOROID:	80009	120-0544-00
A3	670-1004-00			CIRCUIT BD ASSY:SAMPLER	80009	670-1004-00
A3C5 A3C6 A3D80 A3D83	283-0047-00 283-0047-00 152-0141-02 152-0141-02			CAP,FXD,CER DI:270PF,5%,500V CAP,FXD,CER DI:270PF,5%,500V SEMICOND DVC,DI:SW,SI,30V,150MA,30V,DO-35 SEMICOND DVC,DI:SW,SI,30V,150MA,30V,DO-35	59660 59660 03508 03508	0831604Z5F0271J 0831604Z5F0271J DA2527 (1N4152) DA2527 (1N4152)
A3J51 A3J53 A3R4 A3R7 A3R80 A3R81	131-0391-01 131-0391-01 315-0103-00 315-0103-00 317-0101-00 317-0152-00			CONN,RCPT,ELEC:SNAP-ON,MALE CONN,RCPT,ELEC:SNAP-ON,MALE RES,FXD,FILM:10K OHM,5%,0.25W RES,FXD,FILM:10K OHM,5%,0.25W RES,FXD,CMPSN:10O OHM,5%,0.125W RES,FXD,CMPSN:1.5K OHM,5%,0.125W	98291 98291 19701 19701 01121 01121	051-051-0119-22 051-051-0119-22 5043CX10K00J 5043CX10K00J BB1015 BB1525
A3R82 A3R83	317-0101-00 317-0182-00			RES,FXD,CMPSN:100 OHM,5%,0.125W RES,FXD,CMPSN:1.8K OHM,5%,0.125W	01121 01121	BB1015 BB1825
A4	670-1003-00			CIRCUIT BD ASSY:TRIGGER TAKEOFF	80009	670-1003-00
A4C12 A4L10 A4L14	283-0121-00 276-0543-00 276-0543-00			CAP,FXD,CER DI:1000PF,20%,200V SHLD BEAD,ELEK:FERRITE SHLD BEAD,ELEK:FERRITE	91418 80009 80009	5P102M2011958 276-0543-00 276-0543-00

Component No.	Tektronix Part No.	Serial/Assem Effective	nbly No. Dscont	Name & Description	Mfr. Code	Mfr. Part No.
A4L15 A4P3 A4P17	276-0543-00 131-0663-00 131-0565-00	B061638		SHLD BEAD, ELEK: FERRITE CONN, RCPT, ELEC: 3MM CKT BD MT CONN, RCPT, ELEC: SUBMIN COAX, MALE INNER COND (PART OF 175-1042-XX)	80009 24931 71468	276-0543-00 39JR162-1 DM53742-5001
A4Q10 A4Q14 A4R10	151-0212-00 151-0212-00 317-0102-00			TRANSISTOR: NPN,SI,TO-72 TRANSISTOR: NPN,SI,TO-72 RES,FXD,CMPSN:1K OHM,5%,0125W	04713 04713 01121	SRF 518 SRF 518 BB1025
A4R11 A4R12 A4R13 A4R15	317-0510-00 317-0511-00 317-0360-00 317-0102-00			RES,FXD,CMPSN:51 OHM,5%,0.125W RES,FXD,CMPSN:510 OHM,5%,0.125W RES,FXD,CMPSN:36 OHM,5%,0.125W RES,FXD,CMPSN:1K OHM,5%,0125W	01121 01121 01121 01121	BB5105 BB5115 BB3605 BB1025
AT1 D2 J1 R2	119-0178-00 155-0001-00 131-0631-01			ATTENUATOR, FXD:50 OHM, DC-18GHZ, FEEDTHRU, 10X MICROCKT, DGTL:GATE, SPL PKG CONN, RCPT, ELEC:SMA JACK TO SPCL END CONFIG (PART OF D2)	18203 80009 26805	28265001 155-0001-00 ORDER BY DESCR

DIAGRAMS AND CIRCUIT BOARD ILLUSTRATIONS

Symbols and Reference Designators

Electrical components shown on the diagrams are in the following units unless noted otherwise:

Capacitors = Values one or greater are in picofarads (pF).

Values less than one are in microfarads (μ F).

Resistors = Ohms (Ω) .

Graphic symbols and class designation letters are based on ANSI Standard Y32.2-1975.

Logic symbology is based on ANSI Y32.14-1973 in terms of positive logic. Logic symbols depict the logic function performed and may differ from the manufacturer's data.

The overline on a signal name indicates that the signal performs its intended function when it goes to the low state. Abbreviations are based on ANSI Y1.1-1972.

Other ANSI standards that are used in the preparation of diagrams by Tektronix, Inc. are:

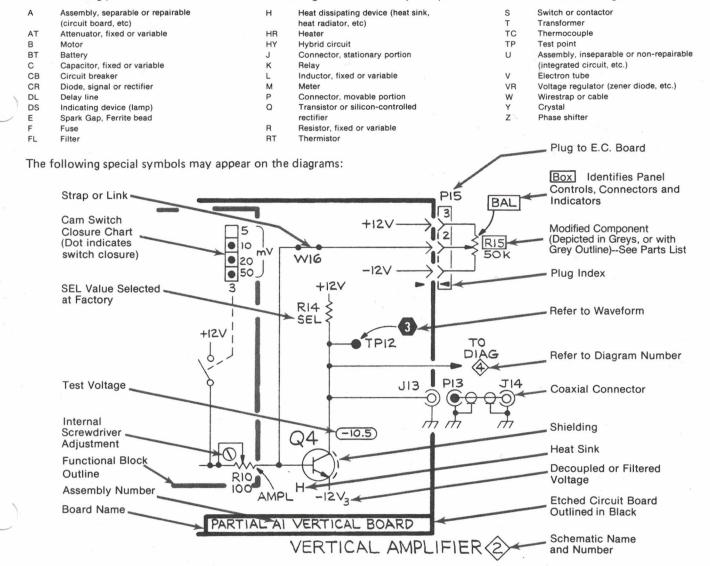
Y14.15, 1966 Drafting Practices.

Y14.2, 1973 Line Conventions and Lettering.

Y10.5, 1968 Letter Symbols for Quantities Used in Electrical Science and

Electrical Engineering.

The following prefix letters are used as reference designators to identify components or assemblies on the diagrams.



PIT TRIGGER PICKOFF TO TRIGGER AMPLIFIER

+50V

GATE

-50V

PREAMPLIFIER

Q36 Q43 Q46

STROBE DRIVE



SAMPLING GATE

DZA THRU DZF

50 L INPUT

STROBE BOARD

TRIGGER

TRANSIENT RESPONSE

GATE

D20 D25 D23 D28

STROBE GENERATOR DGI Q55 Q69

SAMPLER BOARD

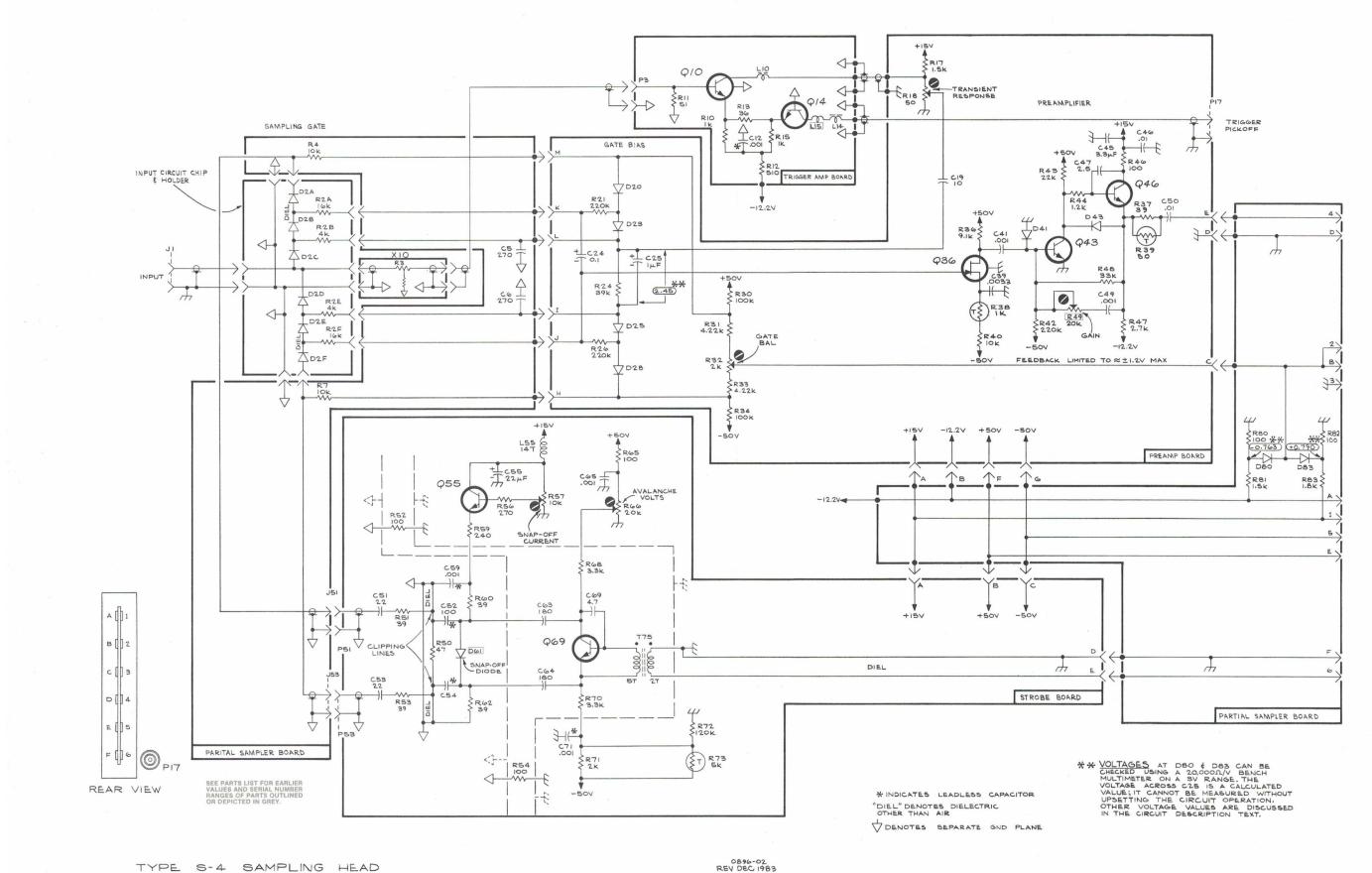
SNAP-OFF CURRENT

AVALANCHE

TRIGGER AMPLIFIER BOARD

XIO

ATTENUATOR



REPLACEABLE MECHANICAL PARTS

PARTS ORDERING INFORMATION

Replacement parts are available from or through your local Tektronix, Inc. Field Office or representative.

Changes to Tektronix instruments are sometimes made to accommodate improved components as they become available, and to give you the benefit of the latest circuit improvements developed in our engineering department. It is therefore important, when ordering parts, to include the following information in your order: Part number, instrument type or number, serial number, and modification number if applicable.

If a part you have ordered has been replaced with a new or improved part, your local Tektronix, Inc. Field Office or representative will contact you concerning any change in part number.

Change information, if any, is located at the rear of this manual.

ITEM NAME

In the Parts List, an Item Name is separated from the description by a colon (:). Because of space limitations, an Item Name may sometimes appear as incomplete. For further Item Name identification, the U.S. Federal Cataloging Handbook H6-1 can be utilized where possible.

FIGURE AND INDEX NUMBERS

Items in this section are referenced by figure and index numbers to the illustrations.

INDENTATION SYSTEM

This mechanical parts list is indented to indicate item relationships. Following is an example of the indentation system used in the description column.

1 2 3 4 5

Name & Description

Assembly and/or Component Attaching parts for Assembly and/or Component

. . . * . . .

Detail Part of Assembly and/or Component Attaching parts for Detail Part

Parts of Detail Part Attaching parts for Parts of Detail Part

Attaching Parts always appear in the same indentation as the item it mounts, while the detail parts are indented to the right. Indented items are part of, and included with, the next higher indentation. The separation symbol - - - * - - - indicates the end of attaching parts.

Attaching parts must be purchased separately, unless otherwise specified.

ABBREVIATIONS

388	INCH	ELCTRN	ELECTRON	IN	INCH	SE	SINGLE END
#	NUMBER SIZE	ELEC	ELECTRICAL	INCAND	INCANDESCENT	SECT	SECTION
ACTR	ACTUATOR	ELCTLT	ELECTROLYTIC	INSUL	INSULATOR		SEMICONDUCTOR
ADPTR	ADAPTER	ELEM	ELEMENT	INTL	INTERNAL	SHLD	SHIELD
ALIGN	ALIGNMENT	EPL	ELECTRICAL PARTS LIST	LPHLDR	LAMPHOLDER	SHLDR	SHOULDERED
AL	ALUMINUM	EOPT	EQUIPMENT	MACH	MACHINE	SKT	SOCKET
ASSEM	ASSEMBLED	EXT	EXTERNAL	MECH	MECHANICAL	SL	SLIDE
ASSY	ASSEMBLY	FIL	FILLISTER HEAD	MTG	MOUNTING	SLFLKG	SELF-LOCKING
ATTEN	ATTENUATOR	FLEX	FLEXIBLE	NIP	NIPPLE	SLVG	SLEEVING
AWG	AMERICAN WIRE GAGE	FLH	FLAT HEAD	NON WIRE	NOT WIRE WOUND	SPR	SPRING
BD	BOARD	FLTR	FILTER	OBD	ORDER BY DESCRIPTION	SQ	SQUARE
BRKT	BRACKET	FR	FRAME or FRONT	OD	OUTSIDE DIAMETER	SST	STAINLESS STEEL
BRS	BRASS	FSTNR	FASTENER	OVH	OVAL HEAD	STL	STEEL
BRZ	BRONZE	FT	FOOT	PH BRZ	PHOSPHOR BRONZE	SW	SWITCH
BSHG	BUSHING	FXD	FIXED	PL	PLAIN or PLATE	T	TUBE
CAB	CABINET	GSKT	GASKET	PLSTC	PLASTIC	TERM	TERMINAL
CAP	CAPACITOR	HDL	HANDLE	PN	PART NUMBER	THD	THREAD
CER	CERAMIC	HEX	HEXAGON	PNH	PAN HEAD	THK	THICK
CHAS	CHASSIS	HEX HD	HEXAGONAL HEAD	PWR	POWER	TNSN	TENSION
CKT	CIRCUIT	HEX SOC	HEXAGONAL SOCKET	RCPT	RECEPTACLE	TPG	TAPPING
COMP	COMPOSITION	HLCPS	HELICAL COMPRESSION	RES	RESISTOR	TRH	TRUSS HEAD
CONN	CONNECTOR	HLEXT	HELICAL EXTENSION	RGD	RIGID	V	VOLTAGE
COV	COVER	HV	HIGH VOLTAGE	RLF	RELIEF	VAR	VARIABLE
CPLG	COUPLING	IC	INTEGRATED CIRCUIT	RTNR	RETAINER	W/	WITH
CRT	CATHODE RAY TUBE	ID	INSIDE DIAMETER	SCH	SOCKET HEAD	WSHR	WASHER
DEG	DEGREE	IDENT	IDENTIFICATION	SCOPE	OSCILLOSCOPE	XFMR	TRANSFORMER
DWR	DRAWER	IMPLR	IMPELLER	SCR	SCREW	XSTR	TRANSISTOR

CROSS INDEX - MFR. CODE NUMBER TO MANUFACTURER

and the second second second

)	Fig. & Index No.	Tektronix Part No.	Serial/Ass Effective	sembly No. e Dscont	Qty	12345	Name & Description	Mfr. Code	Mfr. Part No.
	1-1	386-1337-04	B010100	B039999	1	PANEL.		80009	386-1337-04
		386-1337-11		B073699	ī	PANEL,		80009	
		386-1337-09	B073700		1	PANEL,		80009	
					_		HING PARTS)	00003	360-1337-09
	-2	211-0141-00			4	SCREW,	MACHINE:4-40 X 3.25,PNH,SST TTACHING PARTS)	83486	ORDER BY DESCR
	-3	380-0125-00			1		MPLING HD:ALUMINUM	80009	380-0125-00
	-4	333-1097-00			1	PANEL,	FRONT:		333-1097-00
						(ATTAC	HING PARTS)	00000	000 1007 00
	-5	220-0531-02			1	NUT, PL	AIN,HEX:0.25-36 X 0.312 HEX,BRS NP TTACHING PARTS)	80009	220-0531-02
	-6	105-0338-00			1		ASSEMBLY:	80009	105-0338-00
	-7	386-1338-09			1	SUBPAN	EL, FRONT:		386-1338-09
	-8				1	CKT BO	ARD ASSY:PREAMP(SEE A1 REPL)		
	-9	136-0263-01		B061479	13		T,PIN TERM:U/W 0.025 SQ PIN	00779	85861-2
	1.0	136-0263-07	B061480		13	.SOCKE	T,PIN TERM:U/W 0.025 SQ PIN	22526	ORDER BY DESCR
	-10	136-0252-07			10		T,PIN CONN:W/O DIMPLE		75060-012
	-11	175-1042-00			1		ASSY,RF:50 OHM COAX,3.75 L	80009	175-1042-00
	10						OF A4 ASSEMBLY)		
	-12	120 0050 07			1	CKT BO	ARD ASSY:STROBÉ(SEE A2 REPL)		
	-13 -14	136-0252-07	DO10100	D001 470	6	. SOCKE	T,PIN CONN:W/O DIMPLE		75060-012
	-14	136-0263-04 136-0263-07		B061479	5	. SOCKE	T,PIN TERM:U/W 0.025 SQ PIN	22526	75377-001
	-15	136-0263-07	B061460		5	. SOCKE	T,PIN TERM:U/W 0.025 SQ PIN	22526	ORDER BY DESCR
					2	.P53 R			
	-16				1	CKT BOA	ARD ASSY:SAMPLER(SEE A3 REPL)		
	-17	214-1081-00			4	.PIN,SF	PRING: 0.187 L X 0.034 OD, SST	00287	031X187MDP
	-18	131-0591-00			12	.TERMIN	PRING:0.187 L X 0.034 OD,SST NAL,PIN:0.835 L X 0.025 SQ PH BRZ	22526	
	-19 -20	131-0594-00			3		IAL, PIN: BLACK	22526	47356
			D04.04.00		2	. (SEE A	CPT:50 OHM,COAX,SNAP-ON MALE 3J51,A3J53 REPL)		
	-21	131-0631-00		B074059	1	.CONN,F	CPT, ELEC: 3MM TYPE, FEMALE	22229	2992-6012
		131-0631-01 131-0632-00	B0/4060		1		CPT, ELEC: SMA JACK TO SPCL END CONFIG	26805	ORDER BY DESCR
	-22	131-0032-00			2		T, ELEC: CTR CNDCT, BRASS SIL PL	80009	131-0632-00
					1		RCUIT,DI:GATE,SPL PKG(SEE D2 REPL) ING PARTS)		
	-23	211-0162-00			4	SCREW, M	ACHINE:2-56 X 0.188,SCH,SST TACHING PARTS)	TK0428	ORDER BY DESCR
		214-1398-00			2		HLCPS:0.031 OD X 0.094 L,CLE,MUW,CD	80009	214-1398-00
	-24				1	ATTENUA	TOR,FXD:50 OHM(SEE AT1 REPL)		
	-25						RD ASSY:TRIGGER TAKEOFF(SEE A4 REPL)		
	-26				1		CPT, ELEC: (SEE A4P3 REPL)		
		198-2708-00			1	.WIRE S	ET,ELEC:	80009	198-2708-00
	-27	131-0555-00					,ELEC:GROUNDING,PH BRZ ALBALOY PL F HOUSING)		131-0555-00
		195-0063-00			1	LEAD FR	AME:	80009	195-0063-00
		195-0064-00			1		STBSCP C:	80009	195-0064-00
		224 1500 55				(PART O			
		334-1523-00			1	PLATE, I	DENT: BLANK	TK1617	ORDER BY DESCR



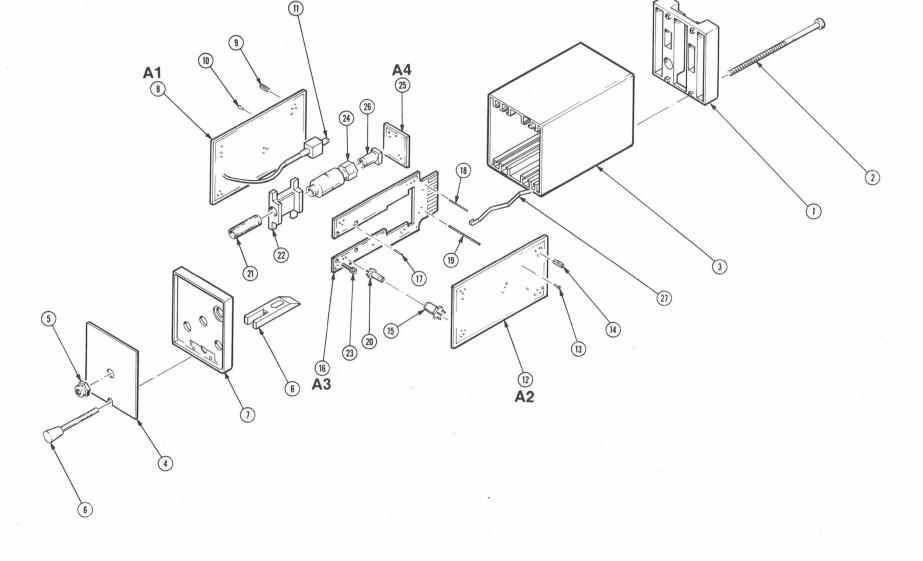
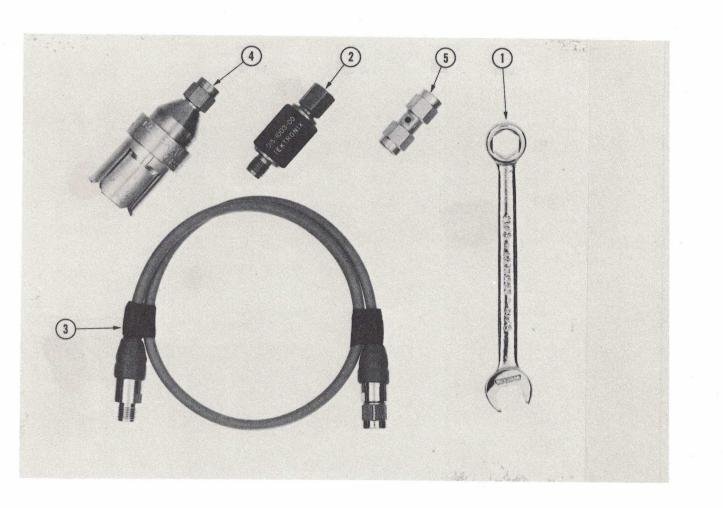


Fig. & Index No.	Tektronix Part No.	Serial/Assembly No. Effective Dscont	Qty	12345 Name & Description	Mfr. Code Mfr. Part No.
2-				STANDARD ACCESSORIES	
-1 -2 -3 -4 -5	003-0247-00 015-1003-00 015-1005-00 015-1007-00 015-1011-00 070-0896-01		1 1 1 1 1	WR,BOX&OE,COMB:0.312,6 POINT ATTENUATOR,FXD:20DB,50 OHM,SERIES SMA,1W CABLE ASSY,RF:50 OHM,2 NS ADAPTER,CONN:GR-874 TO SMA MALE ADAPTER,CONN:SMA MALE TO SMA MALE MANUAL,TECH:INSTR,S4 OPTIONAL ACCESSORIES	80009 003-0247-00 18203 A752AS TK1898 95-C2628-01014 16179 8181-2241-00 16179 2081-0000 80009 070-0896-01
	015-1001-00 015-1002-00 015-1004-00 015-1006-00 015-1008-00 015-1009-00 015-1012-00 015-1013-00 015-1014-00 015-1015-00 015-1016-00		1 1 1 1 1 1 1 1 1 1 1 1 1 1	ATTEN,FXD:2X ATTEN,50 OHM,SERIES SMA CONN ATTEN,FXD:5X ATTEN,50 OHM,SERIES SMA CONN TERMN,COAXIAL:50 OHM,O.5 W,SERIES SMA CABLE ASSY,RF:50 OHM,5NS ADAPTER,CONN:GR-874 TO SMA FEMALE ADAPTER,CONN:SERIES N MALE TO SMA FEMALE ADAPTER,CONN:SERIES APC TO SERIES SMA ADAPTER,CONN:SMM FEMALE TO FEMALE CAPACITOR,CPLG:5000PF,SMA PWR DIVIDER,RES:50 OHM,SMA DELAY LINE,ELEC:50 OHM,O.5NS ADAPTER,CONN:SMA MALE TO 2 SMA FEMALES	18203 A753AS 18203 A751AS 18203 T128CS 02660 ORDER BY DESCR 16179 21210 16179 3082-2241-00 26805 2081-4002-00 16179 2080-0000-00 26805 2046-4003-00 00929 DA-C38 80009 015-1015-00 95077 2996-6001



REV DEC 1983

TYPE S-4

MANUAL CHANGE INFORMATION

At Tektronix, we continually strive to keep up with latest electronic developments by adding circuit and component improvements to our instruments as soon as they are developed and tested.

Sometimes, due to printing and shipping requirements, we can't get these changes immediately into printed manuals. Hence, your manual may contain new change information on following pages.

A single change may affect several sections. Since the change information sheets are carried in the manual until all changes are permanently entered, some duplication may occur. If no such change pages appear following this page, your manual is correct as printed.

